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Composite

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Features

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- Intuitive scalable GUI (metric and imperial)
- Hierarchical tree and grouping of objects
- Boolean operations on overlapping elements
- Fully parameterized and programmable
- Automatic brick meshing with boundary fitting
- Text-based geometry import and export
- Customized library of parameterized objects
- Export of all graphs, pictures and data
- External control through batch commands
- Compatible with MATLAB toolboxes
 (Optimization, Neural Network, Signal Proc.)
- On-line help facility and tutorials

BOUNDARY PROPERTIES

- Perfect electric and magnetic boundaries
- Non-dispersive lossy and abs. TEM boundaries
- Lossy conductors with wideband skin effect
- Wideband dispersive convolution boundaries
- Wideband nonlinear superconducting walls
- Perfectly matched absorbing layers (PML)

MATERIAL PROPERTIES

- Homogeneous and inhomogeneous ε and μ
- Isotropic and anisotropic (tensor) ε and μ
- Electric and magnetic conductivity loss tensors
- Metamaterials with negative refractive index

EXCITATION SOURCES

- Point and spatially distributed (modal) sources
- Hertz dipole and Gaussian beam sources
- · Electric, magnetic and TLM impulse excitations
- Matched (soft) and imposed (hard) sources
- Impulse, step, Gaussian step and pulse, NEMP, Gaussian modulated sin and cos waveforms
- · User-defined waveform specified in text format
- Multiple independent sources and waveforms

DATA AND FIELD DISPLAY MODES

- Dynamic on-the-fly data and field display
- Simultaneous time & frequency responses
- Wire mesh, 3D vector, 2D and 3D color map, 2D and 3D color contour field display
- S-Parameters (Magnitude/Phase & Smith Chart)
- Field integrals (induced voltage, current, electric
- and magnetic flux, power flow) in TD and FD
- E-Plane waveguide frequency mapping
- Cartesian and polar radiation pattern
- Dissipated power density and SAR
- Capture of displays for movie creation
- Backward-in-time simulation mode
- NUMERICAL SOLVERS AND SCRIPTS
- 2D Shunt and Series Node TLM engines
- 3D SCN and GSCN TLM engines
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- Smart memory allocation feature
- · SPICE-EM-bed and MATLAB-EM-bed features
- FD and TD near-to-far field transformation
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 Conductivity, Microstrip, Waveguide and Amplifier Design computations

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Sponsorship Acknowledgement

The Organizers of EMC-Zurich in SINGAPORE 2006 gratefully acknowledges the generous contribution of all Sponsors and the donation of lanyard cords and conference satchels by Schaffner EMC Pte Ltd

PLATINUM

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Schaffner is the international leader in electromagnetic compatibility (EMC), focusing on high-growth sectors such as automotive, building automation, industrial and consumer electronics, aerospace, medical technology, power supplies, telecommunications and transportation as well as the public sector. The Schaffner Group develops, produces and markets standard ans customer-specific components, modules, test systems and test facilities. As a global provider, Schaffner strives to secure and expnad on its leading market positions through a program of innovation, a constant drive for quality cost-efficient practices and customer-focused logistics.

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Table of Contents

	Page
Acknowledgement	
- Sponsors	2
Messages	
- General Chair and Symposium President	5
- Technical Chairs	6
Symposium Committee	
- General Chair	7
- Symposium President	7
 Technical Program Committee Chairs 	7
- Management Committee	7
 Technical Chairs 	8
 International Advisory Committee 	8
General Information	
- Venue Location Map	9
 Registration Hours 	9
- Useful Contact Information	10
- Floor Plan – Level 2: Meeting Rooms	11
- Floor Plan – Level 3: Exhibition Hall and Meeting Rooms	11
 Speaker Guides – Oral/Poster Presentations 	12
- Program Overview and Highlights	14
Symposium Hours And Special Events	
- Symposium Hours	15
- Official Opening & Program	15
- Lunch and Refreshments	15
 IEEE Region 10 EMC Chapter's Retreat and Asia Pacific 	
EMC Chairperson's Meeting	
- IEC SC 77C Project Meeting	16
 Optional Local Tours 	17
 Technical Visit and Evening Reception 	17
- Dinner Banquet	18
Technical Program At A Glance	
- Workshop/ Tutorials	21
- NARTE EMC Certification Examination	30
- Technical Program	31
Exhibition	
- Exhibition Hours	79
- Program	79
- List of Exhibitors	81

Letter from the General Chair and Symposium President



Er-Ping Li

It is our great pleasure to welcome you to EMC-Zurich in Singapore 2006.

The EMC-Zurich, which dates back to 1975, is a premier international event in the field of Electromagnetic Compatibility (EMC). Significantly, the EMC Zurich will for the first time take place outside Europe, and Singapore has been proudly selected to host the EMC Zurich 2006.



Ruediger Vahldieck

The EMC Zurich 2006 in Singapore follows EMC Zurich's excellent tradition and offers you a variety of exceptional programs. It will provide you with a superior platform to showcase your cutting edge research, accomplishments and products, to identify new issues, and to shape future directions for research and industry users in the areas of EMC, RF/Microwave engineering and wireless communications.

The symposium itself will address diverse topics by a variety of invited speakers from all over the world. Besides the stimulating Topical Meetings, Workshops, Tutorials and parallel sessions designed both for academia and industry alike, specially tailored sessions--EMC in Asia, biomedical EM, Automotive EMC, and Wireless communication EMC will be conducted on a large number of interesting EMC topics by acknowledged specialists.

The EMC Zurich 2006 in Singapore will also feature a 3-day International Exhibition on the state-of-the-art EMC and RF/Microwave Measurements and Instrumentation. It will provide an excellent opportunity for your company to showcase your equipments, software or services.

Particularly, in conjunction with this symposium, IEEE EMC Society will also hold its international EMC chapter Chairs retreat meeting, and USA NARTE EMC Certification Examination.

Your presence and contributions to the EMC Zurich 2006 in Singapore will make it an exciting and fruitful event. You will certainly benefit from the exceptional programs we provide, and the networking and quality time you spend with your peers.

I look forward to welcoming you at the EMC Zurich 2006 in Singapore!

Er-Ping Li, Symposium President Ruediger Vahldieck, General Chair

Letter from the Technical Chairs



Todd H. Hubing

nearly three decades, For EMC researchers and practitioners have met every other year in Zurich to hear and present technical papers that have been subjected to one of the most thorough review processes of any engineering conference worldwide. EMC Zurich has become one of the world's premier events for showcasing new technologies and research results at the forefront of the EMC field.



Jian-Guo Ma

A significant factor in this success has been the high quality of its technical programs under the leadership of technical program chairs such as Dr. Clayton Paul and Dr. Fred Tesche.

Now, for the first time, the EMC Zurich symposium is moving to Singapore. It is our hope that this conference will encourage better communication between EMC specialists in Asia and other parts of the world. Although this event is being held more than 6000 miles from Switzerland, the technical program committee has worked hard to ensure that the program and the quality of the technical papers are held to the same high standards set by previous EMC Zurich symposia.

We were overwhelmed by the response to the call for papers for this event. 250 full paper submissions were received. Each paper was reviewed by multiple qualified reviewers and final decisions were made by the technical program committee at a meeting in Singapore. Approximately 70% of the submissions were accepted for oral presentation at the symposium. In addition, more than 40 papers were received under the special topical meetings, which shall feature the advancements and recent developments in the particular areas such as biomedical EMC.

Computational modeling, EMC test procedures and environments, and printed circuit board design papers represent the largest portion of the submissions. However, the number of papers in the areas of integrated circuit design for EMC and intentional EMI seems to be on the rise. Traditional topics such as shielding, grounding and power systems are also well represented. Several papers present unique perspectives or methods that many EMC engineers will find immediately useful.

Whatever your EMC field of specialization, we're sure that you'll find something of interest in this technical program. We hope to see you in Singapore!

Todd H. Hubing

Jian-Guo Ma

Symposium Committees

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Ruediger Vahldieck, ETH, Zurich, Switzerland

Symposium President

Er-Ping Li, IHPC, Singapore

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Co-Chair:	Jianguo Ma, Nanyang Technological University, Singapore

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General Information

Venue - Location map



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- 5 Swissotel The Stamford Singapore
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- 12 Raffles City Shopping Centre
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- 14 Centennial Tower
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- 16 Millenia Tower
- 17 One Raffles Link
- 18 Suntec City Office Towers
- 19 The Fountain of Wealth

Singapore Suntec International Convention & Exhibition Centre 1 Raffles Boulevard Suntec City Singapore 039593 Main Line (65) 6337 2888 Fax (65) 6825 2222 Website <u>www.suntecsingapore.com</u>

Nearest MRT Station: City Hall Station in Raffles City (15 minutes walk)

Registration Hours

Admission to all sessions and hosted functions requires identification. Please wear your name badge at all times.

- 27 February Monday From 7:30am to 5:00pm outside Level 2 Meeting Rooms
- 28 February Tuesday
 From 8:00am to 2:00pm outside Level 2 Meeting Rooms
 From 3:00pm to 8:00pm at Exhibition Hall Level 3 Concourse
- 1 March Wednesday
 From 7:30am to 5:00pm at Exhibition Hall Level 3 Concourse
- 2 March Thursday to 3 March Friday
 From 8.00am to 5.00pm at Exhibition Hall Level 3 Concourse

Useful Telephone Numbers

Symposium Secretariat - Meeting Matters International Cheng-Hoon Khoo (Ms), Conference Manager Tel: (65) 9819 9462 Email: <u>kch@meetmatt.net</u>

Information & Assistance Desk (Feb 27 to 3 Mar) Tel: (65) 9125 9292 Email: info@emc-zurich.org

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Floor Plan - Level 2: Meeting Rooms 203 to 209

Floor Plan – Level 3: Exhibition Hall Concourse and Meeting Rooms 325 and 326



Speaker Guides

Speaker Ready Room (SUNTEC 204 – Level 2)

Opens daily 8:30am to 5:30pm. 1 March – Wed to 3 March – Fri If desired, you may review your presentation materials in this room.

Poster Presentation

Poster sessions will be located on Suntec Level 3 Concourse with the exhibition. Please register at the Registration Desk before proceeding to locate your assigned poster board. To locate your assigned poster board, look for the board marked with your Paper ID.

1. Prepare your poster

Each presenter is provided with a 2.4 metre high by 1 metre wide poster board.

- The presentation must cover the same material as the abstract.
- Place the title of your paper and your paper number prominently at the top of the poster to allow viewers to identify your paper easily. Indicate 1) the abstract's identification number, 2) title, and 3) authors' names.
- Highlight the authors' names, e-mail and address information in case the viewer is interested in contacting them for more information.
- You have complete freedom in displaying your information in figures, tables, text, photographs, etc in the poster.
- Include the background of your research followed by results and conclusions. A successful poster presentation depends on how well you convey information to an interested audience.

2. Set Up Your Poster

- Posters should be set up between 7:30am and 8:30am daily on 1st and 2nd March.
- Posters are scheduled to be on display from 8:30am to 6:00 pm daily on 1st and 2nd March.
- Please make sure that your paper number is clearly visible on your poster board.
- Open forum is as scheduled presenters are required to be at their posters during that time.
- Tapes and other materials are available at the Information Desk, nearby the poster boards.

3. Remove Your Poster

Posters must be removed on the presentation day between 6:000pm and 6:30pm.

Posters remaining after these times will be removed. EMC-Zurich in SINGAPORE 2006 will not be responsible for posters and materials left on poster boards after the stated hours.

4. Information Desk

Staff at the Information Desk will be available to assist you with location and other on-site needs. Tapes and scissors will be available for your use. If you have special needs for your poster presentation, please bring those supplies with you to the meeting.

If you have questions, please contact the Symposium Secretariat at <u>info@emc-zurich.org</u>

Oral Presentation

1. Prepare Your Presentation

Length of presentation material should be in accordance to your time allotted. You are requested to load your presentation materials if it is Power Point before the session starts.

2. Determine Your Audio Visual Needs

All meeting rooms are equipped with the following audio-visual equipment: 1-LCD Projector 1-Window-based PC 1-Screen 1-Laser Pointer

The computers in the meeting rooms are being provided to Windows-based PC users. The PC will be configured with Microsoft Windows XP Professional operating system as well as with Microsoft Office XP.

3. Create a Backup Copy of Your Presentation

We recommend you bring at least 2 copies of your presentation to the meeting in case there is a problem with one of them. Thumb Drive, CD-R and CD-RW are accepted.

4. Give Your Presentation

- Be considerate of the other speakers and audience by staying within your allocated time. The allocated time for your presentation includes a discussion and changeover to the next speaker. Session Chairs will hold you to the allotted time. This is essential to ensure adequate time for questions and discussion as well as adherence to the schedule.
- Please discuss the same materials as reported in your paper submission. At the end of the meeting, all presentation files will be destroyed.

Program Overview and Highlights

27 February - Monday to 3 March - Friday

Delegate Arrival & Registration

27 February - Monday and 28 February - Tuesday

Workshops/Tutorials

28 February - Tuesday

- Booth Dressing for Exhibitors (Level 3, Concourse)
- IEEE EMC Chapter Chair Retreat (SUNTEC Room 204)
- IEC SC 77C Project Meeting (SUNTEC Room 205)

1 March - Wednesday

- Keynote Speeches (SUNTEC Room 325 & 326)
- Technical Visit and Evening Reception (see also Page 16)

1 March - Wednesday to 3 March - Friday

- Technical Sessions
- Topical Meetings
- Technical Exhibition

2 March - Thursday

- Dinner Banquet at the Singapore Night Safari (See also page 17)

Symposium Hours and Special Events

Symposium Hours

1 March - Wednesday to 3 March - Friday, 8:30 AM - 6:00 PM

Official Opening & Program - Meeting Room 325/326 at Level 3

1 March - Wednesday, 8:30 AM - 10.30AM

- Opening Remarks by Symposium Chair
- Official Address by Guest of Honour Prof Er Meng Hwa, Deputy President, Nanyang Technological University, Singapore
- Official Address by the Swiss Ambassador to Singapore, Dr Daniel Woker
- Address by the President of IEEE EMC Society, Dr Andrew Drozd
- Address by the Technical Chairman, Prof. Todd Hubing
- Keynote Speeches by Dr Peter Siegel, NASA JPL, California Institute of Technology, United States
 Bel She Line Level (Technology (CTO)) Main and Level (CTO)
- Rob Shaddock, Chief Technology Officer (CTO), Motorola Inc., USA
- Refreshments and Walkthrough the Technical Exhibition

Refreshments (Workshops/Tutorials - Lunch is on Delegates' Own)

 27 February - Monday to 28 February-Tuesday Outside Meeting Rooms

Refreshments and Daily Lunches - Included in fees

Please present lunch tickets at gate. Thank you.

 1 March - Wednesday to 3 March - Friday, 12:00 PM - 2:00 PM Exhibition Hall at Level 3 Concourse

IEEE Region 10 EMC Chapter's Retreat and Asia Pacific EMC Chairperson's Meeting

28 February (Tuesday), 9:00am to 5pm SUNTEC Room 204

The IEEE Region 10 EMC Chairperson's retreat aims for the exchange of information between the EMC Chairpersons and the EMCS global and regional officers. In addition, the meeting shall also address the issue on one unified Asia Pacific EMC Symposium. It is open to all EMC Chapters and Asia Pacific EMC Chairpersons.

IEC SC 77C Project Meeting

28 February (Tuesday), 9.00am to 5.00pm SUNTEC Room 205

A project meeting for IEC SC 77C (EMC: High power transient phenomena) will be held at SUNTEC Level-2 Room 205 on Tuesday, 28 February from 9:00 am until 5:00 pm. The purpose of this meeting is to begin work on two new publications dealing with high power EM transients. All project team members are invited as are guests who are interested in this field. If there are questions about the subject of the meeting, please contact the SC 77C Chairman, Dr. William Radasky at: wradasky@aol.com.

Optional Local Tours

Find out more about Singapore with the exciting local tours specially arranged for you. For more details and booking, please visit Tour Desk at Exhibition Hall, Level 3.

For enquiries, please contact Tradewinds at Tel 64192188 Fax 64900532 Email: Tradewinds_mice@singaporeair.com.sg Technical Visit and Evening Reception – All Are Welcome

1 March – Wednesday from 6.00 PM Coach Departs Suntec 6:00PM (Please assemble at ground floor main lobby) Coach Departs Nanyang Technological University 9:00PM

> Requires Pre-registration – Closes 2pm on 1 March - Wednesday See Information & Assistance Desk (Level 3 Exhibition Hall)

The Technical Visit and Evening Reception is sponsored by ETS-Lindgrand and Singapore Technologies Electronic LTD

Program

Welcome Reception at the Nanyang Executive Centre 60 Nanyang View, Singapore 639673 Tel: 6790-6697 (Front Desk) Technical Visit to EMERL (in groups of 30 to 35 per trip)

Technical Visit to Electromagnetic Effects Research Lab. (EMERL)

The EMERL (Electromagnetic Effects Research Lab) located within NTU Campus is an initiative spearheaded by DSO in partnership with DSTA, A*STAR-IHPC and NTU. It comprises a Semi-Anechoic Chamber (SAC) and a Mode Stirred Chamber (MSC). The SAC caters to MIL-STD-461E, FCC parts 15 and 18, as well as EN61000-3-X, EN61000-4-X, EN55014 and EN55022 full compliance test requirements. The MSC serves as a MIL-STD-461C radiated emissions test room, as well as the alternative test methods of the MIL-STD-461E RS103 (reverberation technique) and EN61000-4-21 (reverberation technique). Both chambers can accommodate test objects as large as a vehicle. The EMERL test facility is equipped with an integrated test system comprising broadband receiver and complete sets of antenna and test accessories covering from 30 Hz to 40 GHz. In addition, it is also equipped with a computerized radiated susceptibility (immunity) test system capable of generating up to 200V/m of electric field from 10 kHz to 40 GHz, as well as a conducted susceptibility/immunity test system including ESD.



Dinner Banquet at the Singapore Night Safari

2 March - Thursday, from 6:00pm

Coach Departs Suntec 6:15pm Please assemble at ground floor main lobby

Coach Departs Night Safari 11:00pm Please present dinner ticket to coach driver

Other Useful Information Add: 80 Mandai Lake Road, Singapore 729826 Ticket Purchase: See Tour/Hospitality Desk at Level 3 Concourse

The drama and mystery of the tropical jungle comes alive after dusk, at the world's premier Night Safari. Creatures from South America, Asia, & India greet visitors from their own naturalistic enclosures, which simulate that of their own homeland. Not to miss are of course the awesome giraffes towering over the gorgeous reservoir, the rare clouded leopards, and endangered greater Asian rhinoceros and of course the feisty fishing cats. Dine amidst the wild for a totally new exhilarating experience.

Time	Program
6:15pm	Leave Convention Centre for Singapore Zoo (There will be trams to
-	bring guests from the entrance to Forest Lodge)
7:15pm	45 mins Reception at Forest Lodge Entrance
8:00pm	Dinner at Forest Lodge
9:00pm	Journey into the magic & mystery of the Night Safari (There will be
-	trams to bring guests to Night Safari and starts the Night Safari tour)
10:00pm	Catch the Creatures of the Night Show
11:00pm	End of show and return to hotel

		Technical	Program		
Rooms	206	204	207		205
08:30 - 10:30			T3: Fundamentals of EMC & Signal Integrity		Secretariat Room
10:30 - 12:30	T1: EMC Aspects of Lighting	T2: Theory & Practice of Time Domain	W1: Shielding of Electromagnetic Wave		
13:30 - 17:30		Electromagnetics	W2: Transportation and System EMC		
Rooms	206	208	209	204	
08:30 - 12:00	T1: EMC Aspects of Lighting (cont'd)	W4: PCB, IC Packaging & Semiconductor	W6: Naval EMC Engineering	IEEE EMC Chapter Chair Retreat	Secretariat Room
13:00 - 17:40	W3: EMC Simulation and Design	Device EMC			
		W5: RF Biological Effects and Standards Update			
08:30 - 10:30	Opening Ceremony / Keynote speeches	Location: Suntec Room 325 & 326 Level 3			
10:30 - 11:00			Tea Break		I
Rooms	203	208	209	207	Concourse, Level 3
11:00 - 12:40	CEM-1: Computational Electromagnetics	BIO-1: MRI (Invited)	AUTO-1: Automotive EMC	LIGHT-1: Lightning 1	Exhibition
12:40 - 13:40		Lunch Break			
13:40 - 15:20	CEM-2: Materials, Absorbers And Shields	BIO-1: MRI (Cont'd)	PCB-1: EMC AT PCB Level: Practical Cases	MGT: EMC Management & Standards	Poster Session
15:20 - 15:40			Tea Break	·	
15:40 - 18:00	CEM-3: Radiation and Scattering	BIO-2: High Frequency (Invited)	COM-1: SS-Wireless Communication EMC	IEMI-1: SS-Intentional EMI	
08:40 - 10:20	CEM-4: Time-Domain Modeling	COM-2: EMC in Communication	ICEM-1: SS-IC EMC	MAA: Magnetic Material Applications	Exhibition
10:20 - 10:40			Tea Break		
10:40 - 12:20	CEM-5: EM Modelling for Complex Problems	MEAS-1: EMC Measurement Techniques	SI-1: Signal Integrity	LIGHT-2: Lightning 2	Poster Session
12:20 - 13:20			Lunch Break		
13:20 - 15:00	CEM-6: Frequency-Domain Modelling	BIO-3: Biomedical EM	AUTO-2: Automotive EMC	POW-1: Power System EMC	Student Poster Session

Tea Break

Banquet Dinner

Tea Break

PCB-4: Circuit Simulation

Lunch Break

ICEM-2: IC Packaging

Mil-1: EMC in Military

Tea Break

PCB-2: EMC at PCB Level-Design Issues

PCB-3: EMC at PCB Level-Modeling

IEMI-2: Intentional EMI

PROT-1: EMC-Protection

POW-2: Power System EMC

PROT-2: Shielding

Exhibition

NARTE Examination

15:00 - 15:20

15:20 - 18:00

08:40 - 10:20

10:20 - 10:40

10:40 - 12:20

<u>12:20 - 13:20</u> <u>13:20 - 15:00</u>

15:00 - 15:20

15:20 - 18:00

CEM-7: Field-Circuit Interactions

IMMU-1: Immunity Testing

MEAS-3: EMC Testing Facilities

MEAS-2:EMC Measurement Techniques 2

MEAS-4: EMC Measurement Techniques 4

BIO-4: Biomedical

EASIA-1: EMC In Asia

EMI-1: Conducted EMI

IF-1: EMC Industry Forum

COM3: RFID

27 Feb., Mon

28 Feb., Tues

1 Mar., Wed

Workshop Program

27 February 2006, Monday, 8:30am - 17:30pm

Time	Room No.	W/T	Workshop / Tutorial Title
08:30 - 17:30	206	T1	EMC Aspects of Lighting Organizers: F. Rachidi, Switzerland and R. Thottappillil, Sweden
08:30 - 17:30	204	T2	Theory and Practice of Time Domain Electromagnetics Organizers: Wolfgang J.R. Hoefer, Canada
08:30 - 10:30	207	тз	Fundamentals of Electromagnetic Compatibility and Signal Integrity Mark Montrose, USA
10:50 - 12:30	207	W1	Shielding of Electromagnetic Wave George Kunkel, USA
		W2	TRANSPORTATION AND SYSTEM EMC
13:30 - 14:30	207	W2-1	EMC in Fixed Installations and Large Systems Peter Leung, Hong Kong
14:30 - 16:00	207	W2-2	Transportion EMC Alessio Gaggelli and Prof. Sergio A. Pignari, Italy
16:20 - 17:30	207	W2-3	Automotive EMC Achim Gerstner, USA

28 February 2006, Tuesday, 8:30am - 17:30pm

Time	Room No.	W/T	Workshop / Tutorial Title
08:30 - 12:30	206	T1	EMC Aspects of Lighting Organizers: F. Rachidi, Switzerland and R. Thottappillil, Sweden
		W3	EMC SIMULATION AND DESIGN
13:00 - 15:00	206	W3-1	Computational Modelling for EMC Paul Duxbury, UK
15:30 - 17:30	206	W3-2	State of the Arts of 3D EMC Field Simulation Marko Walter, Germany
		W4	PCB, IC PACKAGING & SEMICONDUCTOR DEVICE EMC
08:30 - 09:30	208	W4-1	PCB Radiated Emission Models Todd Hubing, University of Missouri-Rolla, USA
09:30 - 12:00	208	W4-2	Power and Ground Integrity Design in High-speed Chip, Package, and PCB Joungho Kim, KAIST, Korea
13:00 - 13:30	208	W4-3	Semiconductor Device EMC WADA Osami, Kyoto University, Japan
13:30 - 14:00	208	W4-4	Modeling and Verification Techniques to Ensure System-Wide Electromagnetic Reliability Thomas Steinecke, Infineon Technologies AG, Germany
14:00 - 14:30	208	W4-5	EMC Design on Component Level is the Key Success Siegfried Reinhardt, Siemens VDO, Germany
14:30 - 15:30	208	W4-6	Theoretical Consideration & practical Solution for EMC and Reliability Problems for Motor Drive Systems (Power Electronics Device EMC) Wolfgang L. Klampfer, Switzerland
16:00 - 17:30	208	W5	RF Biological Effects and Standards Update Dr. C K Chou, Motorola Inc., USA
08:30 - 17:30	209	W6	Naval EMC Engineering Organizers: F. B.J. Leferink, Netherlands and Elya Joffe, Israel

Workshops / Tutorials

Tutorial 1:	EMC Aspects of Lightning	
Time:	8:30am-05:30pm, Monday, 27 February 2006	
	8:30am-12:30pm, Tuesday, 28 February 2006	
Venue:	SUNTEC Room 206	
Organizers:	F. Rachidi, Swiss Federal Institute of Technology, Switzerland	
	R. Thottappillil, Uppsala University, Sweden	
Co-Sponsor:	Swiss House Singapore	

Abstract

Lightning represents one of the most important sources of electromagnetic disturbances. The objective of this tutorial is to give an overview of measured lightning parameters and modeling its major EMC effects for engineering applications.

Tutorial Outline

8:30am to 5:30pm, Monday, 27 February 2006

8:30-8:35AM: Introduction

8:35AM: T1.1: Lightning Currents for Engineering Applications	
A. Borghetti, University of Bologna, Italy, G. Diendorfer,	OVE-ALDIS,
Austria, V. Rakov , University of Florida, United States	

- **10:20AM: T1.2: Lightning Electric and Magnetic Fields** V.A. Rakov, University of Florida, United States
- 11:25AM: T1.3: Lightning Return Stroke Models and Electromagnetic Field Computation

V. Cooray, R. Thottappillil, Nelson Theethayi, Uppsala University, Sweden

1:30PM: T1.4: Lightning to Tall Structures

Y. Baba, Doshiya University, Japan, F. Rachidi, Swiss Federal Institute of Technology, Switzerland, R. Thottappillil, Uppsala University, Sweden

2:30PM: T1.5: Lightning Location Systems

G. Diendorfer, OVE-ALDIS, Austria, M. Rubinstein, University of Applied Science of Western Switzerland, Switzerland

3:50PM: T1.6: Lightning-Induced Voltages on Power Lines

C.A. Nucci, University of Bologna, Italy, F.Rachidi, Swiss Federal Institute of Technology, Switzerland

5:00PM: Discussions

8:30-12:30pm, Tuesday, 28 February 2006

8:30AM: T1.7: Lightning Protection of Buildings Z.A. Hartono, I.Robiah, Lightning Reasearch Pte Ltd, Malaysia

9:30AM: T1.8: Lightning Protection of Power Systems C.A. Nucci and M. Paolone, University of Bologna, Italy

10:50AM: T1.9: Lightning Interaction with Electrified Railways N. Theethayi and R. Thottappillil, Uppsala University, Sweden

11:50AM: T1.10: Lightning Interaction with Aircrafts

A. Larsson, FOI-Swedish Defense Research Institute, Sweden

12:10-12:30PM: Discussions

Tutorial 2:	Theory and Practice of Time Domain Electromagnetics
Time:	8:30am-5:30pm, Monday, 27 February 2006
Venue:	SUNTEC Room 204
Organizer:	Wolfgang J.R. Hoefer
	University of Victoria, Canada

Abstract

This full-day tutorial provides an introduction to the theoretical foundations, the operational characteristics and the practical engineering applications of time domain electromagnetic simulators. The purpose of this tutorial is to introduce practitioners who are mostly familiar with the classic frequency-domain approaches, to the concepts and operating principles of time-domain electromagnetic simulators, and to show how these translate into their special properties as engineering tools for high-frequency, signal integrity and EMC work.

Speakers: **Wolfgang J.R. Hoefer and Poman P. M. So**, University of Victoria, Canada

EMC-Zurich in SINGAPORE 2006 – Symposium & Technical Exhibition 17th International Zurich Symposium on Electromagnetic Compatibility – February 27 to March 3, 2006

Tutorial 3:	Fundamentals of Electromagnetic Compatibility and Signal Integrity
Time:	8:30am-10:30pm, Monday, 27 February 2006
Venue:	SUNTEC Room 207
Speaker:	Mark Montrose
	Montrose Compliance Inc., United States

Abstract

For those just entering the exciting field of EMC, trying to figure out what to learn and details of fundamental concepts can be a job in itself. Due to lack of universities not offering courses in EMC, (some aspects of EMC may however, be discussed) this course presents a potpourri of concepts and information in a simplified manner. Most engineers enter the field of EMC by default and are thus untrained to think in terms of propagated fields (frequency domain) instead of voltage and current (time domain), which causes electric and magnetic fields to travel through free space or a transmission line.

The focus of this presentation is on fundamental principles that help explain EMC in simplistic terms. Topics of discussion include EMC requirements, non-ideal behavior of passive components, signal spectra, fundamentals of signal integrity related to printed circuit boards, shielding and grounding for EMC. EMC-Zurich in SINGAPORE 2006 – Symposium & Technical Exhibition 17th International Zurich Symposium on Electromagnetic Compatibility - February 27 to March 3, 2006

Workshop 1:	Shielding of Electromagnetic Wave
Time:	10:50am-12:30pm, Monday, 27 February 2006
Venue:	SUNTEC Room 207
Speaker:	George Kunkel
	Spira Manufacturing Corporation, USA

Tutorial Outline

- An Overview of Antenna Theory.
- Penetration of the Wave into/through Shielding Barrier Materials and Seams and Gasketed Joints.
- Test Results of Various Gasketed Joint Combinations.
- Penetration of Shielded Enclosures.
- Corrosion Effects on Shielding.
- Wire and Cable Coupling.
- Test Methods for Shielding Effectiveness of Shielded Cables.

EMC-Zurich in SINGAPORE 2006 – Symposium & Technical Exhibition 17th International Zurich Symposium on Electromagnetic Compatibility – February 27 to March 3, 2006

Workshop 2:	Transportation and System EMC
Time:	1:30pm-5:30pm, Monday, 27 February 2006
Venue:	SUNTEC Room 207
Organizers:	Prof. Sergio A. Pignari
	Politecnico di Milano, Milan, Italy
	Prof Peter Leung
	City University of Hong Kong, Hong Kong, China

Abstract

The workshop consists of three parts: Part I is in a more general and tutorial fashion on EMC assurance and management in Fixed Installation; it could be taken as prerequisite to Part II, which deals with technologies employed in high-speed railways and related critical EMC issues, involving modern trains and infrastructure.

The third part shall cover the automotive EMC Due to the increasing amount of electronic components throughout a vehicle, EMC tests on the subsystem (module) level as well as on the full vehicle become more and more important. This talk will first of all give an update on the current standards situation in the automotive industry. The speaker will overview the details of the different sub tests.

Workshop Outline:

W2.1 EMC in Fixed Installations and Large Systems Peter S. W. Leung, City University of Hong Kong

W2.2 Transportation EMC

Alessio Gaggelli, Trenitalia S.p.A, Sergio A. Pignari, Politecnico di Milano, Italy

W2.3 Automotive EMC

Achim Gerstner, Rohde & Schwarz Inc., Texas, USA

EMC-Zurich in SINGAPORE 2006 – Symposium & Technical Exhibition 17th International Zurich Symposium on Electromagnetic Compatibility – February 27 to March 3, 2006

Workshop 3:	EMC Simulation and Design
Time:	1:00pm-5:30pm, Tuesday, 28 February 2006
Venue:	SUNTEC Room 206
Organizer:	Marko Walter, CST, Germany

Workshop Outline

W3.1:	Computational Modelling for EMC
	Paul Duxbury, Flomerics Ltd, UK

W3.2: State of the Arts of 3D EMC Field Simulation Marko Walter, Computer Simulation Technology, Germany

Workshop 4:	PCB, IC Packaging & Semiconductor Device EMC
Time:	8:30am-3:30pm, Tuesday, 28 February 2006
Venue:	SUNTEC Room 208
Organizers:	Li ErPing, IHPC, Singapore
	Joungho Kim, KAIST, Korea
	Todd Hubing, University of Missouri-Rolla, USA
	Osami Wada, Kyoto University, Japan

Abstract

Clock frequencies of high-speed semiconductor IC's, packages, and systems are increased over GHz frequency ranges. Management of current wave propagation, loss, decoupling, resonance, and radiation at the PDN and the return current path becomes a crucial part of the IC, package, and system co-design in order to maintain power and ground integrity of the system.

In this workshop, we will discuss fundamental design principles and challenges to achieve the electromagnetic reliability, in particular the topics include PCB EMC modeling and design; Power and Ground Integrity Design in High-speed Chip, Package and PCB ; semiconductor device EMC, IC and System-wide Electromagnetic Reliability.

Workshop Outline

- W4.1: PCB Radiated Emission Models Todd Hubing, University of Missouri-Rolla, USA
- W4.2: Power and Ground Integrity Design in High-speed Chip, Package and PCB Joungho Kim, KAIST, Korea

W4.3: Semiconductor Device EMC Osami Wada, Kyoto University, Japan

- W4.4: Modeling and Verification Techniques to Ensure System-Wide Electromagnetic Reliability Thomas Steinecke, Infineon Technologies AG, Germany
- W4.5: EMC Design on Component Level is the Key Success Siegfried Reinhardt, SiemensVDO, Germany
- W4.6: Theoretical Consideration & practical Solution for EMC and Reliability Problems for Motor Drive Systems (Power electronics device EMC) Wolfgang L. Klampfer, Schaffner EMV AG, Switzerland

Workshop 5:	RF Biological Effects and Standards Update
Time:	4:00pm-5:30pm, 28 Feb 2006
Venue:	SUNTEC Room 208
Speaker:	Dr C-K. Chou, Corporate EME Research Laboratory, Motorola Inc., USA

Abstract:

The dramatic increase in man-made radio frequency (RF) fields in the environment during the last few decades has led to public health concerns in many parts of the world. Specifically, questions have been raised on the safety of exposure to RF energy emitted from radar, television and radio communication systems, microwave ovens, video display terminals, and most recently, mobile telephones and base stations. In this presentation, recent epidemiological, human, animal and in vitro studies will be summarized. Reviews of independent expert panels and health authorities will be discussed also. Proper engineering and biological study designs will be emphasized to ensure any observed effects are genuine RF-field induced effects and not due to experimental artifacts. RF dosimetry will be emphasized because the complexity of RF dosimetry is part of the reason why there are so many controversial reports in the literature. Recently developed standards for protecting human health as well as measurement standards for RF emitting devices for compliance requirements will be discussed. Safety standards include the new IEEE C95.1 human exposure guidelines and IEEE C95.7 RF safety program recommendations. The IEEE C95.1 standard will be compared to the 1998 guidelines of the International Commission on Non-Ionizing Radiation Protection. An overview of global RF safety regulations will be presented. Measurement standards to be discussed include IEEE 1528 and IEC 62209 part 1 (characterizing mobile phone exposure in the head) and IEC 62209 part 2 (two-way radios and body worn devices). Harmonization of both RF safety and measurement standards is important for minimizing confusion in global regulations and public concerns.

EMC-Zurich in SINGAPORE 2006 – Symposium & Technical Exhibition 17th International Zurich Symposium on Electromagnetic Compatibility – February 27 to March 3, 2006

Workshop 6:	Naval EMC Engineering
Time:	8:30am-5:30pm, Tuesday, 28 February 2006
Venue:	SUNTEC Room 209
Organizers:	Frank B.J. Leferink, Thales/University of Twente, Netherlands
	Elya Joffe, K.T.M. Engineering, Israel

Abstract:

Modern warships contain a huge number of electromagnetic sensors and electronics. At the same time, the operational shift towards littoral warfare calls for smaller ships, without loss of capabilities. This brings the many sensors in even closer proximity. Functionality may require higher EM-field levels while safety (RadHaz) tries to avoid these in certain areas. As a result, EMC is becoming more and more a critical issue.

EM engineering is an important factor in the total systems engineering effort. Naval EMC engineering involves the necessary activities from concept to deployment phase. In this workshop, shipboard EMC installations will be discussed, including bonding and grounding and lightning protection, as well as modelling and simulations of electromagnetic fields. Furthermore, validation of (large) systems onboard (in-situ) naval vessels will be shown. Some visions about naval ships in the near future will be presented too.

Workshop Outline:

- W6.1: Introduction to Shipboard EMC Moshe Netzer, EMC Engineering and Safety, Israel
- W6.2: Shipboard Electromagnetic Radiation Hazards Moshe Netzer, EMC Engineering and Safety, Israel
- W6.3: Naval Topside EM Modelling and Validation Jasper van der Graaff ,Thales ,Netherlands
- W6.4: Computer Simulation of Shipboard Communications Antennas Franz Schlagenhaufer , Western Australian Telecommunications Research Institute, Australia
- W6.5: Development of Efficient Hybrid Methods for Electrically Large and Complex Electromagnetic Compatibility (EMC) Simulation Xingchang Wei,Institute of High Performance Computing, Singapore
- W6.6: Examples for Shipboard EMC Installations Moshe Netzer, EMC Engineering and Safety, Israel
- W6.7: Naval Integrated Topdeck Design: An Engineering Effort Leading to Integrated Mast Modules Frank Leferink, Thales/ University of Twente, Netherlands
- W6.8: Principles of Shipboard Grounding Elya Joffe, K.T.M. Engineering, Israel
- W6.9: In-situ EMI Testing of Large Naval Radar Systems Using a Vibrating Intrinsic Reverberation Chamber (VIRC) Frank Leferink, Thales/University of Twente, Netherlands

W6.10: European Commission Initiative: 'Standardization for Defence Procurement - European Handbook' By: Expert Group 7, Electromagnetic Environmental Effects Rene Malabiau, French MoD, France, and Frank Leferink, Thales, Netherlands

NARTE EMC Certification Examination

Time: 9:00am to 5:00pm, Friday, 3 March 2006 Examiner: Russell Carstensen Enquiries: NARTE Booth at A11

USA NARTE, a non-profit organization, certifies qualified practitioners of EMC/EMI control. The purpose of NARTE EMC Certification is to foster technical excellence in EMC engineering. This approach establishes competency criteria for EMC/EMI work certification benefits the individual engineer or technician and the EMC community by establishing a standard of excellence in EMC. Details at <u>www.narte.org</u>.

The NARTE EMC Examination is co-locating with the EMC-Zurich Symposium, and is open all the symposium attendees including EMC Engineers, Consultants, Researchers, certification officers, and practitioners, etc. Additional registration fee is required for the examination. Registration is open at the symposium site.

Technical Sessions

AUTO	: Automotive EMC
BIO	: Biomedical EMC
CEM	: Computational Electromagnetics
COM	: Communication EMC
EASIA	: Topical Session-EMC in Asia
ICEM	: IC & Packaging EMC
IEMI	: Intentional Electromagnetic Interference
LIGHT	: Lightning EMC
MEAS	: EMC Measurement and Testing Techniques
MGT	: EMC Management and Standards
Mil	: Topical Session-EMC in Military
MMA	: Magnetic Material Applications
MRI	: Magnetic Resonance Image
PCB	: PCB EMC
POW	: Power System EMC
PROT	: EMC Protection
SI	: Signal Integrity
SS	: Special Session

Keynote Address

Terahertz Technology in Outer and Inner Space By Peter Siegel, California Institute of Technology, United States

Summary

After more than 30 years of niche applications in the space sciences area, the field of Terahertz Technology is entering a true Renaissance. While major strides continue to be made in submillimeter wave astronomy and spectroscopy, the past few years have seen an unprecedented expansion of terahertz applications, components and instruments. Broad popular interest in this unique frequency domain has emerged for the first time, spanning applications as diverse as biohazard detection and tumor recognition. Already there are groups around the world who have applied specialized Terahertz techniques to disease diagnostics, recognition of protein structural states, monitoring of receptor binding, performing label-free DNA sequencing and visualizing contrast in otherwise uniform tissue. A commercial terahertz imaging system has recently started tests in a hospital environment and new high sensitivity imagers with much deeper penetration into tissue have begun to emerge. Solicitations for more sophisticated instruments and enabling terahertz components have filtered into US agency proposal calls from DoD and NASA, to NSF and NIH, and many new research groups have sprung up, both in this country and in Europe and Asia. This talk will broadly survey terahertz technology from its cradle applications in space science and spectroscopy to more recent biomedical and chemical uses.

Speaker Biography:

Peter H. Siegel obtained a BA in astronomy and physics from Colgate University, Hamilton NY in 1976, a Masters in Physics and a PhD in Electrical Engineering from Columbia University in 1978 and 1983 respectively. He has been involved in the analysis and development of millimeter-and submillimeter-wave sensors for over 30 years since 1975. In 1987, He moved to JPL to work on



advanced technology development for NASA astrophysics applications. In 1993, he founded the JPL Submillimeter Wave Advanced Technology team (SWAT) on the development of submillimeter-wave technology for NASA's near and long term astrophysics, Earth remote sensing, and planetary mission applications. At JPL, Dr. Siegel has led or co-I'd more than sixty R&D programs as well as developing and delivering hardware for four major space flight instruments. Recently Dr. Siegel joined the staff at Caltech as a Senior Scientist at the Beckman Institute, Division of Biology, where he is working on biological applications of THz technology. Dr. Siegel and his JPL team have won numerous awards for their technical achievements and are internationally recognized as leaders in THz technology development. Dr. Siegel is a member of AAAS, an elected Fellow of the IEEE, Chair of IEEE MTT Committee 4 -Terahertz Technology and Applications, Vice-Chair of the International Organizing Committee of the Symposium on Infrared and Millimeter Waves (IRMMW), and Organizer of the 33rd IRMMW & 16th THz Electronics Symposium to be held at Caltech in Pasadena, California in 2008 – to which you are all invited!

Technical Program

Keynote Speeches

Title:	Terahertz Applications for Outer and Inner Space
Time:	9:00-9:45am on 1 March 2006
Speaker:	Dr Peter Siegel
	California Institute of Technology, United States
Title:	The Potential of EMC in a Seamless Mobility Environment
Time:	9:45-10:30am, 1 March 2006
Speaker:	Rob Shaddock
	Chief Technology Officer (CTO) for Mobile Devices
	Motorola Inc., USA
Venue:	SUNTEC Room 325/326

Technical Sessions

CEM-1: Computational Electromagnetics (Invited)

Wednesday, 1 March 2006, 11:00am-12:40pm

Chair: Prof. Ruediger Vahldieck SUNTEC Room 203

W1-CEM-1-1 11:00am	Developments of Finite-Volume Techniques for Electromagnetic Modeling in Unstructured Meshes Christophe Fumeaux ¹ , Dirk Baumann ¹ , Pierre Bonnet ² , Ruediger Vahldieck ¹ ¹ Swiss Federal Institute of Technology (ETH), Zurich, Switzerland ² Université Blaise Pascal, LASMEA, Clermont-Ferrand, France
W1-CEM-1-2 11:20am	EMC Computer Modeling of Distributed Wireless Systems to Assure Efficient Utilization of the RF Transmission Hyperspace Andrew Drozd, ANDRO Computational Solutions, United States
W1-CEM-1-3 11:40am	FIT for EMC Marko Walter and Irina Munteanu, CST GmbH, Germany
W1-CEM-1-4 12:00pm	Model Order Reduction for Subgriddding in FDTD Scheme Lukasz Kulas, P Sypek, Jakub Podwalski and Michal Mrozowski Gdansk University of Technology, Poland

W1-CEM-1-5 A State-Space Formulation for Field-Averaging for Finite Volume Models 12:20pm Klaus Krohne , Dirk Baumann and Ruediger Vahldieck Swiss Federal Institute of Technology (ETH), Zurich, Switzerland

CEM-2: Materials, Absorbers and Shields

Wednesday, 1 March 2006, 1:40pm-3:20pm

Chairs: Prof. Zhongxian Shen, Dr. Andrew Drozd SUNTEC Room 203

W1-CEM-2-1	Analysis of Electromagnetic Field Using CIP Method and Its Application of One-Layer Wave Absorber
1:40pm	Shinya Watanabe, Youichi Kakuta and Osamu Hashimoto Aoyama Gakuin University, Japan
W1-CEM-2-2	Fast and Accurate Evaluation of the Shielding Effectiveness of Complex Enclosures
2:00pm	Femke Olyslager and Jan Fostier Ghent University, Belgium
W1-CEM-2-3 2:20pm	Modeling Shielding Properties of Concrete Ade Ogunsola ¹ , Ugo Reggiani ² and Leonardo Sandrolini ² ¹ Parsons Group International, UK ² University of Bologna, Italy
W1-CEM-2-4	Shielding Effectiveness of Cylindrical Enclosures with Annular Ring Apertures
2:40pm	Zhongxiang Shen Nanyang Technological University, Singapore
W1-CEM-2-5 3:00pm	Novel Architecture for Waveguide Based Metamaterials Rakhesh Kshetrimayum Indian Institute of Technology, India

CEM-3: Radiation and Scattering

Wednesday, 1 March 2006, 3:40pm-6:00pm

Chairs: Prof. Le-Wei Li, Prof. Degui Chen SUNTEC Room 203

W1-CEM-3-1	A Symmetric Domain Decomposition Formulation of Hybrid FEM-BEM Coupling for Electromagnetic Analysis
3:40pm	Kezhong Zhao, Marinos Vouvakis, Seung Mo Seo, Seung- Choel Lee and Jin-Fa Lee Obio State University, United States
W1-CEM-3-2	A New Approach for Analysis of Transient Scattering from
4:00pm	Arbitrarily Shaped 3D Dielectric Bodies Ramin Aghajafari and Hermann Singer Technical University of Hamburg-Harburg, Germany
W1-CEM-3-3 4:20pm	Modeling and Simulation of Branched Wiring Network Chet Lo and Cynthia Furse University of Utah, United States
W1-CEM-3-4 4:40pm	Numerical Analysis of Scattering from a General Bi-Isotropic Cylindrical Shell with an Interior Metal Coating Chung-I. G. Hsu, Cheng-Nan Chiu, Chin-Ming Wu and Yu-Cheng Kang Da-Yeh University, Taiwan
W1-CEM-3-5 5:00pm	Hybrid of Periodic Dyadic Green's Function and FEM for Quiet Zone Analysis in Anechoic Chamber Feiyan Lv, Song Chen and Fei Sha Beijing Jiaotong University, Beijing, China

Topical Meeting on Biomedical Electromagnetics

BIO-1: MRI (Invited)

Wednesday, 1 March 2006, 11:00am-12:40pm

Chairs: Tamer Ibrahim and Tommy Vaughn SUNTEC Room 208

W2-BIO-1-1	RF Power Deposition in a Human Model with a Pacemaker in MRI
11:00am	Houman Abrishamkar and Maria Stuchly University of Victoria, Canada
W2-BIO-1-2	2-D and 3-D Homogeneous/Localized Excite Fields at 3 Tesla and 7 Tesla Body Imaging
11:20am	Tamer S. Ibrahim and Roney Abraham The University of Oklahoma, United States
W2-BIO-1-3	Optimization of B1 ⁺ Excitation while Minimizing SAR Hotspots for Phase Amplitude Controlled High Field MRI Using a Hyperthermia Treatment Planning System and Realistic Patient Anatomies
11:40am	C.A.T. van den Berg, B. van den Bergen, J.J.W. Lagendijk, L.W. Bartels and H. Kroeze ¹ University Medical Centre Utrecht, Netherlands
W2-BIO-1-4	Custom Tailored High Frequency B ₁ -Fields for Designer Needs: Uniformity Optimization on Large Parameter Space using Genetic Algorithms and Closed Form Solutions
12:00pm	T. Eagan ¹ , T. Baig ¹ , V. Taracila ¹ , L.Petropoulos ^{1,2} , X.Yang ¹ , H. Fujita ¹ and R. Brown ¹ ¹ Case Western Reserve University, United States ² Hitachi Medial Systems, Twinsburg, Ohio, United States
W2-BIO-1-5	Transceive Grappa: A Scheme for High Field Imaging with Reduced Field/Tissue RF Artifacts
12:20pm	Bing Keong Li, Feng Liu and Stuart Crozier The University of Queensland, Australia

BIO-1: MRI (Invited)

Wednesday, 1 March 2006, 1:40pm-3:20pm

Chairs: Tamer Ibrahim and Tommy Vaughn SUNTEC Room 208

W2-BIO-1-6	Tissue Equivalent Phantoms for High Field Magnetic Resonance Imaging (MRI)
1:40pm	Jeffrey Fitzsimmons ¹ ¹ University of Florida, United States
	² University of Queensland, Australia
W2-BIO-1-7 2:00pm	Highest Field Human Imaging Thomas Vaughan, Lance Dela Barre, Carl Snyder, Lizann Bolinger, Jinfeng Tian, Pat Bolan, Mike Garwood, Gregor Adriany, John Strupp, Andersen and Kamil Ugurbil University of Minnesota, United States
W2-BIO-1-8	SAR and Temperature: Calculations and Comparison to Regulatory Limits for MRI
2:20pm	Christopher M. Collins ¹ , Weihua Mao ¹ , Wanzhan Liu ² , and Michael B. Smith ¹ ¹ The Pennsylvania State University, College of Medicine, United States ² University of Minnesota, Center for MR Research, United States
W2-BIO-1-9	Modeling of Pacing Lead Electrode Heating in the MRI RF Field
2:40pm	Piotr Przybyszewski ¹ , M. Wiktor ² and M. Mrozowski ² ¹ Medtronic Inc. USA ² Technical University of Gdansk, Poland
W2-BIO-1-10	Implementation of Mode-Scanning Excitation Method with a 16-ch Transmit/Receive Volume Strip Array at 7T
3:00pm	R. Lee ¹ , R. Brown ² , G. Mizsei ³ , R. Xue ¹ , Y. Wang ² , Roney Abraham ⁴ , Tamer Ibrahim ⁴ and C. Stephanescu ¹ ¹ New York University, United States ² Cornell University, United States ³ Mont Sinai School of Medicine, United States ⁴ The University of Oklahoma, United States

BIO-2: High Frequency (Invited) Wednesday, 1 March 2006, 3:40pm-6:20pm

Chairs: Prof. Michal Okoniewski and Prof. Koichi Ito SUNTEC Room 208

W2-BIO-2-1	On Various 'Worst Case' Situations for Power Absorption in Homogeneous and Heterogeneous Phantoms
3:40pm	Benoît Derat ¹ and Jean-Charles Bolomey ²
	² SUPELEC, France
W2-BIO-2-2	Temperature Rise in the Human Eye and Orbit due to RF Exposure Calculated with a Realistic Vascularised Model: Temperature Distributions and the Enormous Impact of Cooling by Perfusion
4:00pm	V.M.M. Flyckt, B.W. Raaymakers, H. Kroeze and J.J.W. Lagendijk University Medical Centre Utrecht, Netherlands
W2-BIO-2-3	EMF Estimations in a Train Carriage: Assessing Implantable
	Cardiac Pacemaker EMI from Cellular Radios
4:20pm	Yusuke Abiko ¹ , Takashi Hikage ¹ , Louis Harris ¹ , Masahiko Hirono ¹ , Toshio Nojima ¹ , Manabu Omiya ¹ , Masaaki Komazaki ² , Soichi Watanabe ³ and Takashi Shinozuka ³ ¹ Hokkaido University, Japan
	² Nippon COMSYS Corporation, Japan ³ National Institute of Information and Communication Technology, Japan
W2-BIO-2-4	Hybrid Analysis of SAR in Human Body for Base-Station
4:40pm	Masayuki Komatsu ¹ , Jianqing Wang ¹ , Osamu Fujiwara ¹ and Shinji Uebayashi ²
	¹ Nagoya Institute of Technology, Japan ² NTT DoCoMo Inc, Japan
W2-BIO-2-5	Development and Application of Human Voxel Models
5:00pm	Tomoaki Nagaoka and Soichi Watanabe
	National Institute of Information and Communications Technology Japan
W2-BIO-2-6	Dosimetric Analysis for Human Exposure to Body-Mounted Wireless Devices
5:20pm	Min-Young Park, Chea-Ok Ko and Jeong-Ki Pack Chungnam National University, South Korea

EMC-Zurich in SINGAPORE 2006 – Symposium & Technical Exhibition 17th International Zurich Symposium on Electromagnetic Compatibility – February 27 to March 3, 2006

W2-BIO-2-7	Experimental Investigation of Breast Cancer Detection using a Fully-populated Array of Antennas and Real Aperture Synthetically Organised Radar
5:40pm	I. J. Craddock ¹ , R. Nilavalan ² , J. Leendertz ¹ , A. Preece ¹ and R. Benjamin ¹ ¹ University of Bristol, United Kingdom ² Brunel University, United Kingdom
W2-BIO-2-8	Thin Coaxial Antennas for Interstitial and Intracavitary Microwave Thermal Therapies
6:00pm	Koichi Ito and Kazuyoki Saito Chiba University, Japan

AUTO-1: Automotive EMC

Wednesday, 1 March 2006, 11:00am-12:40pm

Chairs: Prof. Robert Weigel, Guenter Seibert SUNTEC Room 209

W3-AUTO-1-1	Design Methodology to Limit Electromagnetic Coupling
	Between Board Tracks on PCB Level in Realtime
11:00am	Alexander Stadler ¹ , Manfred Albach ¹ , Hans Roßmanith ¹ and
	Mr Göran Schubert ²
	¹ University of Erlangen-Nuremberg, Germany
	² Conti-TEMIC Microelectronic GmbH, Germany
W3-AUTO-1-2	Inductive and Capacitive Couplings in DC Motors with
	Built-In Damping Chokes
11:20am	Jens Benecke and Stefan Dickmann
	Helmut-Schmidt-Universität (Universität der Bundeswehr
	Hamburg), Germany
W3-AUTO-1-3	Analysis of Cable Parameters on the Real Chassis by
	Measurement
11:40am	Shaofeng Yu, Wei Li, Bo Zhang, Jinliang He and Yong Huang
	Tsinghua University in Beijing, China
W3-AUTO-1-4	Simulation and Analysis of Electromagnetic Environment for
	the Mobile Receiver
12:00pm	JungHoon Kim and JoongGeun Rhee
1	Hanvang University South Korea

PCB-1: EMC at PCB Level - Practical Cases

Wednesday, 1 March 2006, 1:40pm-3:20pm Chairs: Prof. Frank Leferink, Prof. Jianguo Ma SUNTEC Room 209

W3-PCB-1-1 1:40pm	Iterative Methods for Reluctance Based PEEC Models Martin Zitzmann ¹ , Tanja Clees ² and Robert Weigel ¹ ¹ University of Erlangen-Nuremberg, Germany ² Fraunhofer Institute for Algorithms and Scientific Computing, Germany
W3-PCB-1-2	Improved Impedance Calculation of Populated PCB Power- Bus Structures
2:00pm	Matthias Hampe and Stefan Dickmann Helmut-Schmidt-University, Germany
W3-PCB-1-3	Hybridized 3D-FDTD and Circuit Simulator For Analysis of PCB Via's Signal Integrity
2:20pm	Xiaoshe Zhai, Zhengxiang Song, Yingsan Geng, Jianhua Wang and Degui Chen Xi'an Jiaotong University, China
W3-PCB-1-4	Parameterized Macromodels for Lossy Multiconductor Transmission Lines
2:40pm	Stefano Grivet-Talocia ¹ , Silvia Acquadro ¹ , Carlo Peraldo ¹ , Flavio Canavero ¹ , Ilkka Kelander ² , Markku Rouvala ² , Ali Arslan ² ¹ Politecnico di Torino, Italy ² Nokia Research Center, Finland
W3-PCB-1-5	Comparison of Methods for Calculating the Loading Effect of Capacitors on Power Ground Planes
3:00pm	Joe Trinkle and Antonio Cantoni Western Australian Telecommunication Research Institute, Australia

COM-1: SS-Wireless Communication EMC

Wednesday, 1 March 2006, 3:40pm-5:20pm

Chair: Prof. Peter Leung SUNTEC Room 209

W3-COM-1-1	Crosstalk Immunity Improvement in Digital Systems Using Binary Phase Shift Keying
3:40pm	Vicente Gonzalez, Enrique Sanchis, Alberto Valero
	University of Valencia, Spain
W3-COM-1-2	SAR Compliance in Australia – Requirements for Mobile and Portable Transmitting Devices
4:00pm	Chris Zombolas, Aaron Sargent
1	EMC Technologies Pty Ltd, Australia
W3-COM-1-3	RFI Assessment on Human Safety of RFID System at Hong Kong International Airport
4:20pm	Y F Wong ¹ , Paul W K Wu ¹ , Daniel M H Wong ¹ , Denny Y K Chan ¹ , L C Fung ² and S W Leung ²
	¹ Hong Kong Airport Authority, Hong Kong, China
	² City University of Hong Kong, China
W3-COM-1-4	Co-existence of GSM1800 and GSM1900: BTS-to-BTS Interference
4:40pm	N. Petchinda ¹ , S. Malisuwan ^{1,2} , P. Ritthiruangdech ³ and V. Ungvichian ⁴
	¹ Rangsit University, Thailand
	² Chulachomklao Royal Military Academy, Thailand
	³ Office of Auditor General, Thailand
	⁴ Florida Atlantic University, Thailand
W3-COM-1-5	To Estimation of Level of Co-Channel Interference in the Communication Systems
5:00pm	Vladimir B. Trigubovich
-	Belarusian Medical Academy of Post-Graduate
	Education, Belarus

LIGHT-1: Lightning EMC

Wednesday, 1 March 2006, 11:00am-12:40pm

Chairs: Prof. Vladimir.A. Rakov, Prof. Liew Ah Choy SUNTEC Room 207

W4-LIGHT-1-1	Transmission Line Model of Lightning Return Strokes Generalized to Include a Tall Grounded Strike Object and an Upward Connecting Leader
11:00am	Yoshihiro Baba ¹ and Vladimir Rakov ² ¹ Doshisha University, Japan ² University of Florida, United States
W4-LIGHT-1-2	Computation of Power Line Tower Lightning Surge
	Impedance Using the Electromagnetic Field Method
11:20am	Changzheng Gao, Lin Li, Bing Li and Zhibin Zhao
	North China Electric Power University, China
W4-LIGHT-1-3	A Review of Studies on Early Streamer Emission and Charge
	Transfer System Conducted in Malaysia
11:40am	Zainal Hartono and Ibrahim Robiah
	Lightning Research PLC, Malaysia
W4-LIGHT-1-4	Comparison of On-line Lightning Monitoring System Data with Derived EM Responses of Space Launch Systems to
12.00	Lightning
12:00pm	Jason Chai, A. Britting, Jr. and Samuel Feng
	The Aerospace Corporation, United States
W4-LIGHT-1-5	A TDOA Based Approach for Locating Cloud-to-Ground
12:20pm	Paria Sattari, Keyhan Sheshyekani, Mehran Hazrati, Rouzbeh Moini and Seyed Hossein Sadeghi Amirkabir University of Technology, Iran

MGT-1 EMC Management and Standards

Wednesday, 1 March 2006, 1:40pm-3:20pm

Chairs: Elya Joffe, Andrei Marinescu SUNTEC Room 207

W4-MGT-1-1 1:40pm	EMC Progress in Romania Andrei Marinescu ¹ , Aurelia Scornea ¹ and Lucian Ursea ² ¹ ICMET R&D Institute, Romania
	² Ministry of Economy and Commerce, Romania
W4-MGT-1-2 2:00pm	Research for EMI Basic Standards (Invited) Manfred Stecher
	Rohde & Schwarz, Munich, Germany
W4-MGT-1-3	Efficient Identification of Major Contributions to EMI- induced Rectification Effects in Analog Automotive Circuits
2:20pm	Johan Loeckx and Georges Gielen
	ESAT/MICAS (K.U.Leuven), Belgium
W4-MGT-1-4	Impedance Bond Mitigation of Inductive Interference to Railway Wayside Signal Systems
2:40pm	Rod Perala
	Electro Magnetic Applications Inc., United States
W4-MGT-1-5	EMC Technology Roadmapping: A Long-Term Strategy
3:00pm	Marcel van Doorn
-	Philips Electromagnetics & Cooling Competence
	Center, Netherlands

IEMI-1: SS- Intentional EMI

Wednesday, 1 March 2006, 3:40pm-6:00pm

Chair: Dr William Radasky SUNTEC Room 207

W4-IEMI-1-1	The Threat of Intentional Electromagnetic Interference (IEMI) to Wired and Wireless Systems
3:40pm	W. Radasky, Metatech Corp., United States
W4-IEMI-1-2 4:00pm	Dangerous Pulse Excitation of Coupled Lines A. M. Zabolotsky ¹ , T. R. Gazizov ¹ , A.G. Bova ¹ and W.A. Radasky ² ¹ Tomsk State University of Control System and Radioelectronics, Russia ² Metatech Corp., USA
W4-IEMI-1-3	HPEM and HEMP Susceptibility Assessments of Computer
4:20pm	R. Hoad, A. Lambourne and A. Wraight QinetiQ, United Kindom
W4-IEMI-1-4 4:40pm	IEMI Against Modern Civilian Electronic Technologies O. H. Arnesen, E. Krogager, M. Backstrom, S. Bo-Sande, J. Godo, S. Harkonen, K. Lovstrand, M. Moisio, B. Nordstrom, J. Peltonen and O. Oystad Norwegian Defence Research Establishment, Norway
W4-IEMI-1-5 5:00pm	Susceptibility of WLAN and GPS Systems: An Initial Study T. Nilsson, O. Lunden and M. Backstrom Swedish Defence Research Agency, Sweden
W4-IEMI-1-6	Susceptibility of Sensor Networks to Intentional
5:20pm	Jerker Delsing ¹ , Jonas Ekman ¹ , Jonny Johansson ¹ , Sofia Sundberg ¹ , Mats Backstrom ² and Tony Nilsson ² ¹ Lulea University of Technology, Sweden ² FOI-Swedish Defence Research Agency, Sweden
W4-IEMI-1-7	Resistance to Extended IEMI by Physical/Correlated Wireless Random and Non-random Networks
5:40pm	H. Potrykus ¹ and I. Kohlberg ² ¹ Institute for Defense Analyses, United States ² Kohlberg Associate, Inc., United States

Open Forum-1: Poster Session Wednesday, 1 March 2006, 1:40pm-3:40pm

Chairs: Dr. Zhang Yaojiang, Dr. Sungtek Kahng Suntec Level 3, Concourse

W-OF-001	Method of Forces: A Novel Approach for Finding Current Distributions on Single and Coupled Microstrip Lines Mehdi Ardavan and Ahmad Cheldavi Iran University of Science & Technology, Iran
W-OF-002	Effect of Water Contents and Dissolved Salt in the Sand under High Impulse Currents (P013) Norlina Mohamad Nor Multimedia University, Malaysia
W-OF-003	An Improved Printed Double-Y Balun Luming Deng ¹ , Xingchang Wei ² , Erping Li ² and Yilong Lu ¹ ¹ Nanyang Technological University, Singapore ² Institute of High Performance Computing, Singapore
W-OF-004	Reverberation Chambers - Design and Application for EMC Ralf Heinrich and Uwe Karsten Schaffner Electrotest GmbH, Germany
W-OF-005	Active Diagnostics of the Failures in Printed-Circuit-Boards V. N. Dianov Moscow State Industrial University, Russia
W-OF-006	Air-Gap Effect Shielding on Multiple Reflection at 900MHz Toshihide Tosaka ¹ , Isamu Nagano ² , Satoshi Yagitan ⁱ² , Toshio Matsumot ^{o2} , Nobuyasu Hiramatsu ³ and Hiroto Nomura ³ ¹ National Institute of Information and Communications Technology, Japan ² Kanazawa University, Japan ³ Hiramatsu Industrial Company, Japan
W-OF-007	Study on the Effect of Metal Strips Loaded on the Walls of the DC Power-Bus Sungtek Kahng, University of Incheon, South Korea
W-OF-008	Different Excitation Feed Models for Full-wave Simulation of Aperture Antenna Systems Zaw Zaw Oo ¹ and Le-Wei Li ² ¹ Institute of High Performance Computing, Singapore, ² National University of Singapore

W-OF-009	Crosstalk Characterizations of Unshielded Twisted-Pair Cable using the Electromagnetic Topology Techniques Phumin Kirawanich ¹ David Gleason ¹ , S. Yakura ² and N. Islam ¹ ¹ University of Missouri at Columbia, United States ² Air Force Research Laboratories, United States
W-OF-010	EMC Design of Automation Equipment in Power System Baoming Xiao, Jingbo Fu and Zhicheng Liang Nanjing Automation Research Institute, China

CEM-4: Time-Domain Modeling

Thursday, 2 March 2006, 8:40am-10:20am

Chairs: Prof. W.J.R. Hoefer, Dr. Zhejie Liu SUNTEC Room 203

T1-CEM-4-1	Improvement of Field Distribution in a Reverberation Chamber by Phase Shift of Exciting Wires, Calculated by TLM
8:40am	Djonny Weinzierl ¹ , Arnulf Kost ^{2,} and Adroaldo Raizer ³ ¹ Centro Universitário de Jaraguá do Sul, Brazil, ² Brandenburgische Technische Universitaet Cottbus, Germany
	³ Universidade Federal De Santa Catarina, brazii
T1-CEM-4-2	Hanging Variables in Finite Element Time Domain Method with Hexahedral Edge Elements
9:00am	N. Venkatarayalu ^{1,3} , Robert Lee ² , Yeow-Beng Gan ¹ and
	¹ Temasek Laboratories, National University of Singapore, Singapore
	² Ohio State University, United States ³ National University of Singapore Singapore
	radonal entreisity of enigapore, enigapore
T1-CEM-4-3	Extraction of Circuit Parameters for Transmission Lines by Compact 2D FDFD Method
9:20am	En-Xiao Liu ^{1,2} , Er-Ping Li ^{1,2} and Le-Wei Li ² ¹ Institute of High Performance Computing, Singapore ² National University of Singapore, Singapore
T1-CEM-4-4	A Kind of Mathematical Model of Numerical Calculation of Substation Grounding Grids in Time-Varving Fields
9:40am	Huina Yang North China Electric Power University, China
T1-CEM-4-5	Subcell FDTD Modeling of Electrically Thin Dispersive Layers Using Z Transforms
10:00am	Chaoqun Jiao, Xiang Cui and Lin Li North China Electric Power University, China

CEM-5: EM Modeling of Complex Problems

Thursday, 2 March 2006, 10:40am-12:20pm

Chairs: Dr. Poman So, Prof. Tat-Soon Yeo SUNTEC Room 203

T1-CEM-5-1	An Accelerated Non-Conforming DP-FETI Domain Decomposition Method for the Analysis of Large EMC Problems
10:40am	Kezhong Zhao and Jin-Fa Lee Ohio State University, United States
T1-CEM-5-2	Computational Study of Significant Semi-Infinite Integrals in Electromagnetic and Atomic Interactions
11:00am	Cheng-Wei Qiu ^{1,2} , Le-Wei Li ¹ , Tat-Soon Yeo ¹ , Said Zouhdi ² ¹ National University of Singapore, Singapore ² Ecole Superieure D'Electricite, France
T1-CEM-5-3	Fast Solution of Foldy-Lax Equations for Two-dimensional Radiation and Scattering Problems
11:20am	Zhang Yao Jiang and E P Li Institute of High Performance Computing, Singapore
T1-CEM-5-4	On the Use of the Equal Area Rule for the Wire-Grid Representation of Metallic Surfaces
11:40am	Abraham Rubinstein ¹ , Cyrous Rostamzadeh ² , Marcos Rubinstein ³ and Farhad Rachidi ¹ ¹ Swiss Federal Institute of Technology, Switzerland ² Robert Bosch Corporation, United States ³ Univeristy of Applied Science of Western Switzerland, Switzerland
T1-CEM-5-5	On the Use of Wavelet Transform for Efficient Iterative Solution of the Electromagnetic Models in Lightning Studies
12:00pm	Amir Geranmayeh, Rouzbeh Moini and S. H. Hesam Sadeghi Amirkabir University of Technology, Iran

CEM-6: Frequency-Domain Modeling Thursday, 2 March 2006, 1:20pm-3:00pm

Chairs: Prof. Yilong Lu, Prof. W.J.R. Hoefer SUNTEC Room 203

T1-CEM-6-1	Calculation of Dynamic Write Field for Perpendicular
	Recording Head
1:20pm	Z. J. Liu ¹ , J.T. Li ² , H. H. Long ^{1,2} , E. P. Li ³ , E. T. Ong ¹ and K. S. Chai ¹
	¹ Data Storage Institute, Singapore
	² Hitachi Global Storage Technology Singapore Pte Ltd, Singapore
	³ Institute of High Performance Computing, Singapore
T1-CEM-6-2	Proper Orthogonal Decomposition in Reduced Order Model Generation for Microwave Problem
1.40nm	W11 Zhong Lin Yao Jiang Zhang and Fr Ping Li
1.40pm	Institute of High Performance Computing, Singapore
T1-CEM-6-3	Harmonics Study for Three-Phase Transformer under DC
2:00pm	Xiaoping Li, Xishan Wen, Cixuan Chen, Lan Lei Wuhan University, China
T1-CEM-6-4	Electric and Magnetic Fields around an Unloaded via Port Structure
2:20pm	Matthew Wood and Franz Schlagenhaufer
	Western Australian Telecommunications Research
	Institute, Australia
T1-CEM-6-5	The Study of Nonlinear Characteristic Curve for the Core of Transformer with Magnetic Coupling
2:40pm	Xiaoping Li, Xishan Wen, Cixuan Chen and Lan Lei Wuhan University, China

CEM-7: Field-Circuit Iterations

Thursday, 2 March 2006, 3:20pm-5:20pm

Chairs: Prof. Ban-Leong Ooi, Prof. Ruediger Vahldieck SUNTEC Room 203

T1-CEM-7-1	Electromagnetic Radiation from a Trace on a Dielectric Substrate
3:20pm	Franz Schlagenhaufer The University of Western Australian, Australia
T1-CEM-7-2	Efficient Closed-Form Green's Functions for Multilayered Structure and Its Applications on Circuit Analysis
3:40pm	Tao Yuan, Le-Wei Li, Jian-Ying Li and Mook Seng Leong National University of Singapore, Singapore
T1-CEM-7-3	A New Analog Behavioral Module Linking Field and PSPICE-Circuit Simulations for Transient Analysis
4:00pm	Huilian Du ¹ , Dan Gorcea ² , Poman So ¹ and Wolfgang J.R. Hoefer ¹
	¹ University of Victoria, Canada ² Flextronics, Canada
T1-CEM-7-4	Calculation of Per-Unit-Length Parameters for Shielded and Unshielded Twisted Pair Cables
4:20pm	Fahd Hassoun, R. Tarafi and A.Zeddam France Telecom R&D RESA/FACE, France
T1-CEM-7-5	Optimization of a Reflectarray Antenna via Hybrid Evolutionary Algorithms
4:40pm	F.Grimaccia ¹ , M. Mussetta ¹ , P. Pirinoli ² , and R. Zich ¹ ¹ Politecnico di Milano, Italy ² Politecnico di Torino, Italy
T1 CEM 7 6	Determination of Distribution Eulerions and Parameters for
11-CEIVI-7-0	the Preisach Hysteresis Model
5:00pm	Piyabutr Pruksanubal, Chulalongkorn University, Thailand, A. Binner, K.H. Gonschorek, Dresden University of Technology, Germany

COM-2: EMC in Communication

Thursday, 2 March 2006, 8:40am-10:20am

Chairs: Prof. Donglin Su, Dr. Jean-Philippe Parmantier SUNTEC Room 208

Prediction Design of the Noise and Gain Specifications of the RF Receiver
Qiong Wang and Donglin Su
Beijing University of Aeronautics and
Astronautics, China
Simultaneous Estimation of Mutual Coupling Matrix and DOAs for UCA and ULA
Tongtong Zhang ¹ , Yilong Lu ¹ and Hon Tat Hui ²
¹ Nanyang Technological University, Singapore
² University of Queensland, Australia
Analysis on Interference of DS-UWB Signal to Narrowband Systems
Tao Jiang ¹ , Xuehuan Wang ¹ and Zhengang Cui ²
¹ University of Harbin Engineering, China
² Heilongjiang Communication Corporation, China
Analyses of Several Realistic Exposure Scenarios near Cellular Base Stations
Revaz Zaridze, David Kakulia, George Kajaia, Dmitriy
Mazmanov, Tamriko Gogua, Nino Jejelava and Liana Manukyan
Tbilisi State University, Georgia
Directional UWB Planar Antenna for Operation in the 5- 20 GHz Band
Marco Pevrot-Solis ^{1,2} , Giselle Galvan-Tejada ¹ and Hildeberto
Jardon-Aguilar ¹
¹ CINVESTAV-IPN, Mexico
² Mexican Navy Research Institute, Mexico

MEAS-1: EMC Measurement Techniques Thursday, 2 March 2006, 10:40am-12:20pm

Chairs: Dr. Franz Schlagenhaufer, Chris Zombolas SUNTEC Room 208

T2-MEAS-1-1	Simultaneous EM Measurement System Using Parallel Modulated Probe Array (Invited)
10:40am	Qiang Chen ¹ , Kunio Sawaya ¹ , Tomohiro Habu ² and Ryoichi Hasumi ² ¹ Tohoku University, Japan ² Device Co., Ltd, Japan
T2-MEAS-1-2	Magnetic Near-field Probe for GHz Band and Spatial Resolution Improvement Technique
11:00am	Hiroki Funato and Takashi Suga Hitachi Ltd., Japan
T2-MEAS-1-3	Wireless Digital Data Acquisition System for EMI Measurement in Power Substations
11:20am	W H Siew, Yu Wang and Mir Faheem University of Strathclyde, United Kingdom
T2-MEAS-1-4	Direct Diagnostic Testing of Phased Array Antennas Using IR Imaging Techniques
11:40am	John Norgard and Randall Musselman Air Force Research Lab, DF/DFEE, United States
T2-MEAS-1-5 12:00pm	Time Domain Calibration of Pulsed Current Probe Lihua Shi, Jianwen Tan and Bihua Zhou Nanjing Engineering Institute, China

BIO-3: Biomedical EM

Thursday, 2 March 2006, 1:20pm-3:00pm

Chairs: Prof. Jianqing Wang, Prof. Jeong-Ki Pack SUNTEC Room 208

T2-BIO-3-1	Electromagnetic Components in Silicon-on-Insulator (SOI) Waveguide for BioSensing Applications
1:20pm	Soon Thor LIM, Jason Png and Er Ping LI
1	Institute of High Performance Computing, Singapore
T2-BIO-3-2	Detection of Hip Prosthesis Depth Change Using an E- Pulse Technique
1:40pm	Hoi-Shun Lui, Nicholas Shuley, Shantanu Kumar Padhi and Stuart Crozier
	University of Queensland, Australia
T2-BIO-3-3	Implications of the Revised ICNIRP Electric Field Exposure Guideline on the Design of Overhead AC Power Lines- 400KV and Above
2:00pm	Roy Hubbard ¹ and Pieter Pretorius ² ¹ Empetus Close Corporation, South Africa ² Eskom Holding Ltd, South Africa
T2-BIO-3-4	Accuracy Control of Finite Difference Time Domain (FDTD) Method Using Method of Auxiliary Sources (MAS) and Investigation of Correlation between SAR and Temperature Rise
2:20pm	Alexander Razmadze, Levan Shoshiashvili, David Kakulia, George Kajaia, Nino Jejelava and Revaz Zaridze Tbilisi State University, Georgia
T2-BIO-3-5 2:40pm	Review of the Research and Development in EIT Guizhi Xu, Huanli Wu, Shuo Yang, Ying Li, Shuai Zhang, Qingxin Yang and Weili Yan HeBei University of Technology, China

BIO-4: Biomedical

Thursday, 2 March 2006, 3:20pm-6:00pm

Chairs: Dr. Maria Stuchly and Prof. Ian Craddock SUNTEC Room 208

T2-BIO-4-1	Tissue Sensing Adaptive Radar for Breast Cancer Detection: Experimental Verification of an Improved Skin Sensing Method
3:20pm	Trevor Williams and Elise Fear
I	University of Calgary, Canada
T2-BIO-4-2	Experimental and Theoretical Investigation into a Microwave Breast Cancer Detection System
3:40pm	Wee Chang Khor, Hua Wang, Marek Bialkowski and Stuart Crozier University of Oceanoland, Australia
	University of Queensiand, Australia
T2-BIO-4-3	Time Domain Characterization of Dielectric Target in a Half Space Using Complex Natural Resonance Method
4:00pm	Shantanu Padhi, Nicholas Shuley, Hoi-Shun Lui and Stuart Crozier
	University of Queensland, Australia
T2-BIO-4-4 4:40pm	Multi-Frequency Imaging System of EIT with DSP Guizhi Xu,Shuai Zhang, Huanli Wu, Duyan Geng,
	Qingxin Yang and Weili Yan HeBei University of Technology, China
T2-BIO-4-5	FDTD Analysis of UWB Pulse Interaction with Biological Tissues
5:00pm	Hooi Been Lim and Hui Xin Tan
	Institute of High Performance Computing, Singapore
T2-BIO-4-6	The Electromagnetics of Wireless Brain Machine Interface Operation
5:20pm	Doney Abraham, Robert Rennaker and Tamer S. Ibrahim University of Oklahoma, United States
T2-BIO-4-7	The Design of a Fully Integrated Regional Hyperthermia-3T MRI System for the Treatment of Pelvic Tumours
5:40pm	B. van den Bergen, C.A.T. van den Berg, L.W. Bartels, J.J.W. Lagendijk, H. Kroeze and A.A.C. de Leeuw University Medical Centre Utrecht, Netherlands
T2-BIO-4-8	Application of Electromagnetic Modeling in Biophotonics: Characterizing Sub-Cellular Changes Using Visible Light
6:00pm	Xu Li, Yang Liu, Allen Taflove and Vadim Backman Northwestern University, United States

ICEM-1: SS - IC EMC Modeling (Invited)

Thursday, 2 March 2006, 8:40am-10:20am

Chair: Prof. Osami Wada SUNTEC Room 209

T3-ICEM-1-1	Evaluation of Packages by Simulating IC Emission with LECCS Model
8:40am	Eiji Takahashi, Takeshi Nakayama and Yoshiyuki Saito Matushita Electric Industrial Co. Ltd., Japan
T3-ICEM-1-2	A LECCS Model Parameter Optimization Algorithm for EMC Designs of IC/LSI Systems
9:00am	Nobuo Funabiki ¹ , Yohei Nomura ¹ , Jun Kawashima ¹ , Yuichiro Minamisawa ¹ and Osami Wada ² ¹ Okayama University, Japan ² Kyoto University, Japan
T3-ICEM-1-3	Simulation of Integrated Circuit Immunity with LECCS Model
9:20am	Kouji Ichikawa ^{1,2} , Masashi Inagaki ¹ , Yukihiko Sakurai ¹ , Isao Iwase ¹ , Makoto Nagata ² and Osami Wada ³ ¹ Denso Corporation, Japan ² University of Kobe, Japan ³ Kyoto University, Japan
T3-ICEM-1-4	Analysis of Electromagnetic Susceptibility on High Speed Circuits Located in a Shielded Enclosure
9:40am	Hla Phyu ¹ , Er-Ping Li ¹ and Weiliang Yuan ² ¹ Institute of High Performance Computing, Singapore ² United Test and Assembly Center Ltd, Singapore
T3-ICEM-1-5 10:00am	Standardization of EMC Models of IC/LSI Osami Wada Kyoto University, Japan

SI-1: Signal Integrity

Thursday, 2 March 2006, 10:40am-12:20pm

Chairs: Mark Montrose, Dr Albert Lu SUNTEC Room 209

T3-SI-1-1	Generation of Common-Mode Currents on PCB Power-Bus Structures
10:40am	Matthias Hampe and Stefan Dickmann Helmut-Schmidt-University, Germany
T3-SI-1-2	Study on Delay Time Characteristics of Shielded
10-01-1-2	Meander Lines
11:00am	Shigeo Nara and Kohji Koshiji
	Tokyo University of Science, Japan
T3-SI-1-3	Characterization of SSN Coupling to Signal Via in Multi- Layer PCBs and Packages
11:20am	Jongbae Park ¹ , Hyungsoo Kim ² , Jun So Pak ³ and Joungho Kim ¹
	¹ Korea Advanced Institute of Science and
	Technology, South Korea
	² Hynix Semiconductor Inc., South Korea
	³ National Institute of Advanced Industrial Sci. & Tech., Japan
T3-SI-1-4	Modeling RF Voltage Drop of Printed Circuit
11.10	Interconnects Using a Full-Wave Approach
11:40am	Eng Kee Chua, Kye Yak See and Zhihong Liu
	Nanyang Technological University, Singapore
T3-SI-1-5	SPICE Model Extraction for Signal Integrity Analysis of
	Unshielded Twisted Pairs from Full Wave Simulation
12:00pm	Rodolfo ARANEO ¹ , Spartaco ANIGGIA ² and F.MARADEI ¹
	¹ University of Kome "La Sapienza", Italy
	² EIVIC Consultant, Italy

AUTO-2: SS-Automotive EMC Thursday, 2 March 2006, 1:20pm-3:00pm

Chairs: Prof. Robert Weigel, Andreas Gstoettner SUNTEC Room 209

T3-AUTO-2-1 1:20pm	Hybrid Solver Strategies in Automotive EMC Simulation Martin Zitzmann ¹ , Robert Grillmair ² , Tanja Clees ³ and Robert Weigel ¹ ¹ University of Erlangen-Nuremberg, Germany ² University of Applied Science Munich, Germany ³ Fraunhofer Institute for Algorithms and Scientific Computing, Germany
T3-AUTO-2-2	The Influence of Ground and Floating Planes on the
1:40pm	Alexander Stadler ¹ , Manfred Albach ¹ , Hans Rossmanith ¹ and Goeran Schubert ²
	¹ University of Erlangen-Nuremberg, Germany ² Conti-TEMIC Microelectronic GmbH, Germany
T3-AUTO-2-3	Odd-Mode Impedance-Controlled Shielded Flat Flexible Cables for In-Vehicle Data Transmission
2:00pm	Volker Zwillich ¹ , Wolfgang Menzel ¹ , Lars Roehrig ² and Helmut Leier ³
	¹ University of Ulm,Germany
	² Innovation Technology AG, Germany ³ DaimlerChrysler AG, Germany
T3-AUTO-2-4	EMC Analysis of Planar PCB-Based Coils in the Vicinity of the Automobile Carriage
2:20pm	Stephan Schuh and Manfred Albach
	University Erlangen-Nuremberg, Germany
T3-AUTO-2-5	Behavioral Modelling of ICs for Investigations of Conducted Emissions in Automotive Systems
2:40pm	Guenter Seibert ¹ , Dieter Metzner ² , Frank Klotz ² , Georg
_	Pelz ² and Robert Weigel ¹
	¹ University Erlangen-Nuremberg, Germany
	-infineon Technologies, Germany

PCB-2: EMC at PCB Level - Design Issues Thursday, 2 March 2006, 3:20pm-6:00pm

Chairs: Prof. Todd Hubing, Prof. Frank Leferink SUNTEC Room 209

ТЗ-РСВ-2-1	PCB Design Techniques for the SI and EMC of Gb/s Differential Transmission Lines
3:20pm	Keith Armstrong
-	Cherry Clough Consultants, United Kingdom
ТЗ-РСВ-2-2	A Simple Method of Crosstalk Reduction by Metal Filled Via Hole Fence in Bent Transmission Lines on PCBs
3:40pm	Jong Ho Kim and Dong Chul Park
1	Chungnam National University, South Korea
ТЗ-РСВ-2-3	EMC Shielding in Power Electronics Multilayers with Conductive Permeable Material
4:00pm	Stephan Schuh and Manfred Albach
1000111	University of Erlangen-Nuremberg, Germany
T3-PCB-2-4	Power Tracks Instead of Planes to Reduce Radiated Electromagnetic Fields
4·20pm	Frank Leferink ^{1,2} and Wim C van Etten ²
1.20pm	1Thales Netherlands
	² University of Twente, Netherlands
T3-PCB-2-5	Double and Single Summation Expression for the Impedance of Populated PCB Power-Bus Structures
	Including Asymmetrically Connected Components
4:40pm	Matthias Hampe and Stefan Dickmann
	Helmut-Schmidt-University, Germany
ТЗ-РСВ-2-6	An Efficient Approach for the Power/Ground Plane Equivalent Circuit Extraction
5:00pm	Zhi Hong Liu ¹ , Kye Yak See ¹ , Er Ping Li ² and Eng Kee Chua ¹ ¹ Nanyang Technological University, Singapore
	Anstitute of Fligh Performance Computing, Singapore

MMA-1: Magnetic Material Applications Thursday, 2 March 2006, 8:40am-10:20am

Chairs: Prof. Qingxin Yang, Lee Hill SUNTEC Room 207

T4-MMA-1-1 8:40am	Utilizing Overlooked Characteristics of Ferrites for Improved Printed Circuit Board EMI Suppression Lee Hill ¹ and Jeff Bruce ² ¹ Silent Solutions LLC (SILENT), United States ² Steward Inc, United States
T4-MMA-1-2	Study on Method of Modelling and Controlling of Magnetostrictive Material
9:00am	Jinlong An, Qingxin Yang and Zhengpin Ma Hebei University of Technology, China
T4-MMA-1-3	Calculation of Effective Impedance of Common-mode Choke Made of Mn-Zn Ferrite
9:20am	Daming Zhang and Ruifeng Huang Nanyang Technological University, Singapore
T4-MMA-1-4	Improvement on the Properties of SiC Absorbers
9:40am	Xiao-Ning Zhang and Qing Wang China Power Science & Technology, China
T4-MMA-1-5 10:00am	Micromagnetic Modeling Simulations and Applications H.H Long ¹ , Dr Z.J Liu ² , Dr E.T Ong ³ and Dr E. P Li ³ ¹ Hitachi Global Storage Technology Singapore Pte Ltd, Singapore, ² National University of Singapore, Singapore ³ Institute of High Performance Computing, Singapore

LIGHT-2: Lightning

Thursday, 2 March 2006, 10:40am-12:20pm

Chairs: Dr. Farhad Rachidi, Rashide SUNTEC Room 207

T4-LIGHT-2-1	On the VLF/LF Radiation Pulse Shapes at the Initial Millisegonde of Lightning Discharges (Invited)
10:40am	Xuan-Min Shao ¹ and Matthew Heavner ²
	¹ Los Alamos National Laboratory, United States
	² University of Alaska Southeast, United States
T4-LIGHT-2-2	Numerical Analysis of the Charge Distribution on Building Structure in the Preliminary Breakdown Phase of Lightning
11:00am	Q. B. Zhou and Y. Du
	Hong Kong Polytechnic University, China
T4-LIGHT-2-3	Ionization Gradient of Low Resistivity Soils and Liquids
11:20am	Normiza Mohamad Nor
	Multimedia University, Malaysia
T4-LIGHT-2-4	Real-Time Detection of Lightning Electromagnetic Field
	Data: A Wavelet Approach
11:40am	Keyhan Shehyakani, Mehran Hazrati, Paria Sattari,
	Hesam Sadeghi and Rouzbeh Moini
	Amirkabir University of Technology, Iran

POW-1: Power System EMC

Thursday, 2 March 2006, 1:20pm-3:00pm

Chairs: Prof. Xiang Cui, Prof. Michel Ianoz SUNTEC Room 207

T4-POW-1-1	Analysis of Ionized Field under ±800kV HVDC
	Transmission Lines
1:20pm	Tiebing Lu, Jie Zhao, Xiang Cui and Han Feng
	North China Electric Power University, China
T4-POW-1-2	Toward a Global Approach Dedicated to Electromagnetic
	Compatibility and Energy Efficiency
1:40pm	JP. Gonnet ¹ , JM. Guichon ² , A. Anglade ³ , N. Maïzi ⁴ ,
	V. Mazauric ¹ , J. Roudet ² , P. Wendling ⁵
	¹ Schneider Electric Corporate Research, France
	² Laboratoire d.Electrotechnique de Grenoble, France
	³ Agence de l.Environnement et de la Maitrise de
	l.Energie, France
	⁴ Centre de Mathématiques Appliquées, Ecole des Mines
	de Paris, France
	⁵ Magsoft Corporation, United States
T4-POW-1-3	Feasibility Study of Optical Isolator in Reducing CM
	Conducted Emission from PLC Modem
2:00pm	Azran Kamarul, Kye Yak See and Ping Lam So
1	Nanyang Technological University, Singapore
T4-POW-1-4	A Modeling Method for Simulation Analysis of
	Electromagnetic Susceptibility Problem
2:20pm	Ai Min Zhang, De Gui Chen, Hang Zhang and Gang Jiang
1	Xi'an Jiaotong University, China
T4-POW-1-5	Analysis of Resonance in Transformer Windings under Very
	Fast Transient Overvoltages
2:40pm	Haifeng Sun ¹ , Guishu Liang ¹ , Xile Zhang ^{1,2} and Xiang Cui ¹
_	¹ North China Electric Power University, China
	² Baoding Tianwei Baobian Electric Co., Ltd, China

IEMI-2: Intentional EMI

Thursday, 2 March 2006, 3:20pm-5:00pm

Chairs: Prof Wenyan Yin, Dr. William Radasky SUNTEC Room 207

T4-IEMI-2-1	Generation and Measurement of a Wide-Band Calculable Electromagnetic Pulse
3:20pm	Takashi Iwasaki ¹ , Mohamed Naushad ¹ and Lira Hamada ² ¹ University of Electro-Communications, Japan ² National Institute of Information and Communications Technology, Japan
T4-IEMI-2-2	Radiated Electric Field Strength from High-Power Microwave Systems
3:40pm	Anders Larsson ¹ , Bo Johansson ² and Sten E Nyholm ¹ ¹ FOI-Swedish Defense Research Agency, Sweden ² Swedish Armed Forces, Sweden
T4-IEMI-2-3	Breakdown Predictions of Microstrip Interconnects and Coplanar Waveguide-Built Devices in the Presence of HP- EMPs (Invited)
4:00pm	Wen-Yan Yin ¹ , Xiaoting Dong ² , Junfa Mao ¹ and Lewei Li ² ¹ Shanghai Jiaotong University, China ² National University of Singapore, Singapore

Open Forum-2: Poster Session Thursday, 2 March 2006, 10:40am-12:20pm

Chairs: Dr. James Cai, Dr Daming Zhang SUNTEC Level 3, Concourse

T-OF-001	Computational Modeling to Predict Hazards of Electromagnetic Radiation Mark Tan ¹ and Boon Hui Lim ² ¹ Institute of High Performance Computing, Singapore, ² ST Electronics (InfoComm) Ltd, Singapore
T-OF-002	A Novel Multi-Source Model to Predict the Radiated Emissions with a Time-domain EMI Measurement System Stephan Braun and Peter Russer, Technische Universität München, Germany
T-OF-003	Artificial Dielectric Circular Resonator with Novel Anisotropic Permittivity and Its Spurious Property Control Achmad Munir, Takeshi Uemura and Hiroshi Kubo Yamaguchi University, Japan
T-OF-004	A Novel Design Scheme for Optimizing EMI and Efficiency of Continuous Mode PFC Converters Supratim Basu ¹ , Tore Undeland ² ¹ Bose Research Pvt Ltd, India ² Chalmers University of Technology, Sweden
T-OF-005	An Integrated Approach in EMC Management for Railway Projects Samuel Chan, Samuel Goh and Peng Hiong Than Land Transport Authority, Singapore
T-OF-006	Coupling Effect between Chip Bonding Wire and Signal Trace on PCB Chung Hsiung Yeh, Kai Chuan Hung and Randall Lan Ming Hsin University of Science and Technology, Taiwan
T-OF-007	Simulation of EMC Problems Caused by Lightning Using Cartesian Analytical Expressions Fernando Zago ¹ , Jose Pissolato Filho ¹ and Geraldo Caixeta ² ¹ UNICAMP State University of Campinas, Brazil ² University São Francisco-CCET, Brazil
T-OF-008	Effects of Direct Lightning on Grounding Grids and EMC Problems Fernando Zago ¹ , Henry Mesa ¹ , Geraldo Caixeta ² and Jose Pissolato Filho ¹ ¹ UNICAMP State University of Campinas, Brazil, ² University São Francisco-CCET, Brazil

EMC-Zurich in SINGAPORE 2006 – Symposium & Technical Exhibition 17th International Zurich Symposium on Electromagnetic Compatibility – February 27 to March 3, 2006

T-OF-009	Computation of Underground Electromagnetic Fields Generated by the Lightning Return Stroke T.T AnilKumar ¹ , P. Duraikannu ² ¹ Govt. College of Engineering Kannua, India ² National Institute of Technology Karnataka, India
T-OF-010	Novel Route to Perovskite Lead Titanate from Lead and Titanium Glycolatesvia via Sol-Gel Process Nuchnapa Tangboriboon, Alexander Jameison, Anuvat Sirivat and Sujitra Wongkasemjit Materials Engineering, Thailand
T-OF-011	Evaluation Method and Design of Multi-Layered Absorber using an NSGA-II Algorithm Ki-Bum Jung ¹ , Hyung-Do Choi ² and Yeon-Choon Chung ³ ¹ EMC Center, South Korea ² Electronics and Telecommunications Research Institute, Korea ³ SeokyeongUniversity, Korea
Student Prize Competition Poster Session Thursday, 2 March 2006, 1:20pm-3:20pm Chairs: Prof. Todd Hubing, Prof. Flavio Canavero SUNTEC Level 3 Concourse (exhibition area)

The papers for student prize shall be presented at this session. To qualify for the student prize, the student must be the principal author and also the presenter.

MEAS-2: EMC Measurement Techniques Friday, 3 March 2006, 8:40-10:20am

Chairs: Prof. Flavio Canavero, Dr. Kwok Soohoo SUNTEC Room 203

F1-MEAS-2-1	Erratic Nature of Product ESD Immunity Testing Investigated Using a Dual TEM Cell (Invited)
8:40am	Kwok Soohoo, Andrew Rybak and Michael Wielgos IBM Corporation, United States
F1-MEAS-2-2	Field Distribution and Over-Moding in a TEM Cell
9:00am	Paul Kay
	University of South Australia, Australia
F1-MEAS-2-3	Parametric Analysis of NSA Data by the Methods of Piecewise Multiple Linear Regression
9:20am	David Wang, Ken Huang Lin and Mon-Na Lo Huang
	National Sun Yat-Sen University, Taiwan
F1-MEAS-2-4	An Efficient Modeling Method for Analysis of Shielding
	Rooms
9:40am	Sheng Wang and Hooi Been Lim
	Institute of High Performance Computing, Singapore

IMMU-1: Immunity Testing

Friday, 3 March 2006, 10:40am-12:00pm

Chairs: Keith Armstrong, Chris Zombolas SUNTEC Room 203

F1-IMMU-1-1 10:40am	EMI and Functional Safety Why Traditional Immunity Testing Is Inadequate, and What Should be Done Instead Keith Armstrong Cherry Clough Consultants, United Kingdom
F1-IMMU-1-2 11:00am	Effects of DC Cable Routing in Immunity Testing Subramanian Chidambaram, Keng Kok Khoo and Jason White Hewlett Packard Singapore (Private) Limited, Singapore
F1-IMMU-1-3	Radiated Immunity Measurement Comparison between OSL and Chamber
11:20am	Tae Heon Jang and Won Seo Cho Korea Testing Laboratory (KTL), South Korea

MEAS-3: EMC Testing Facility

Friday, 3 March 2006, 1:20pm-3:00pm

Chair: Garth D'Abreu, Prof. Jinliang He SUNTEC Room 203

F1-MEAS-3-1 1:20pm	Analysis of Correction Factor for Site Attenuation Shinichi Ohtsu ¹ , Makoto Mukai ² , Shuichi Kobayashi ³ , Katsuyuki Tanakajima ³ , Seiichi Kawashima ⁴ , Jiro Kawano ⁵ and Atsuya Maeda ⁵ ¹ Fujitsu Ltd, Japan ² Japan Electro-Magnetic Soft Development, Japan ³ Akzo-Nobel K.K., Japan ⁴ Voluntary EMC Laboratory Accreditation Centre, Japan ⁵ Japan Voluntary Control Council for Interference by IT Equip., Japan
F1-MEAS-3-2	Prediction of Maximum Electric Field with Given Independent Sampling Points in a Reverberation Chamber
1:40pm	Daming Zhang ¹ , Kye Yak See ¹ and Wee Jin Koh ² ¹ Nanyang Technological University, Singapore ² DSO National Laboratories, Singapore
F1-MEAS-3-3	Comparison of Field Uniformity Characteristics in a Triangular Reverberation Chamber with ORS Diffusers
2:00pm	Eugene Rhee and Joong-Geun Rhee Hanyang University, South Korea

EMC-Zurich in SINGAPORE 2006 – Symposium & Technical Exhibition 17th International Zurich Symposium on Electromagnetic Compatibility - February 27 to March 3, 2006

F1-MEAS-3-4 2:20pm	Status of Standards for Alternate Test Sites Friedrich-Wilhelm Trautnitz Albatross Projects GmbH, Germany
F1-MEAS-3-5	Antenna Height Scan for Minimizing EUT Emission Measurement Uncertainty in Fully Anechoic Chambers
2:40pm	above 1 GHz Tian Hong Loh and Martin Alexander National Physical Laboratory, United Kingdom

MEAS-4: EMC Measurement Techniques

Friday, 3 March 2006, 3:20pm-5:00pm

Chairs: Prof. Qiang Chen, Manfred Stecher SUNTEC Room 203

F1-MEAS-4-1	A Novel Realtime Time-Domain EMI Measurement System Based on Field Programmable Gate Arrays
3:20pm	Stephan Braun, Mohammed Al-Qedra and Peter Russer Technische Universität München, Germany
F1-MEAS-4-2	Shielding Effectiveness Measurements using a
	Reverberation Chamber
3:40pm	Frank Leferink ¹ , Noel Steentjes ² , Hans Bergsma ¹ and Wim van Etten ²
	¹ Thales, Netherlands
	² University of Twente, Netherlands
F1-MEAS-4-3	Improved Reproducibility of Conducted Emission
	Measurements
4:00pm	Manfred Stecher
_	Rohde & Schwarz, Munich, Germany

COM-3: RFID

Friday, 3 March 2006, 8:40am-10:20am

Chairs: Prof. Peter Leung, Dr. James Cai SUNTEC Room 208

F2-COM-3-1 8:40am	Effect of Internal Patch Antenna Ground Plane on SAR Kwok Hung Chan, L.C.Fung, S.W.Leung and Y.M.Siu City University of Hong Kong, China
F2-COM-3-2	Analyze of Dielectric Coated Personal Communication Systems (PCS) Antenna and Study of its Field Interaction with the User
9:00am	Giorgi Ghvedashvili, George Kajaia, Giorgi Saparishvili and Revaz Zaridze Tbilisi State University, Georgia
F2-COM-3-3	Operational Considerations in Simulation and Deployment of RFID Systems
9:20am	Kin Seong Leong, Mun Leng Ng and Peter Cole University of Adelaide, Australia
F2-COM-3-4	Analysis of the Electromagnetic Behavior of a Thin Finite Slot Aperture through Wiener-Hopf Technique
9:40am	Riccardo Zich and Daniele Monopoli Politecnico di Milano, Italy

EASIA-1: Special Topic -EMC in Asia Friday, 3 March 2006, 10:40am-12:20pm

Chairs: Dr. Leslie Bai, Dr. Erping Li SUNTEC Room 208

F2-EASIA-1-1 10:40am	China Approvals - Break through the Unwritten Law Leslie Bai ¹ , Peter Lin ² and Andrew He ² ¹ SIEMIC Inc., United States ² SIEMIC Info Tech., Ltd, China
F2-EASIA-1-2	EMC Technology Development of Modern China Telecommunication Field
11:00am	He Guili and He Jianqiang Ministry of Information Industry, China
F2-EASIA-1-3 11:20am	Progress of VCCI's Industry Self-Regulations in Japan and a Look to the Future (Asia) Akihisa Sakurai VCCI & EMC of IBM, Japan
F2-EASIA-1-4 11:40am	EMC Regulations and Test Activities in Singapore Daniel Yeo and Deng Jun Hong PSB Corporation, Singapore
F2-EASIA-1-5	New Regulatory Requirements in Taiwan for Information Technology Equipment (ITE)
12:00pm	Leslie Bai and Jackie Deng SIEMIC, Inc., United States

EMI-1: Conducted EMI

Friday, 3 March 2006, 1:20pm-3:00pm

Chairs: Dr. Daming Zhang, Prof. Gao YouGang SUNTEC Room 208

F2-EMI-1-1	Measurements of Conducted Voltage in the Low-Frequency Range from 2 kHz to 30 MHz for High-Current Industrial Applications with Regeneration Drives
1:20pm	Fabian Beck and Wolfgang Klampfer Schaffner EMV AG, Switzerland
F2-EMI-1-2	Study on Board-Level Noise Filters to Prevent Transient- Induced Latchup in CMOS Integrated Circuits during EMC/ESD Test
1:40pm	Sheng-Fu Hsu and Ming-Dou Ker
	National Chiao-Tung University, Taiwan
F2-EMI-1-3	Characterization of RF Noise Source Impedance for Switched Mode Power Supply
2:00pm	Junhong Deng ¹ and Kye Yak See ²
	¹ PSB Corporation, Singapore
	² Nanyang Technological University, Singapore
F2-EMI-1-4	A New Integrated Inductor with Balanced Switching Technique for Common Mode EMI Reduction in High Step- up DC/DC Converter
2:20pm	T. Dumrongkittigule ¹ , V. Tarateeraseth ² and W. Khan-ngern ¹ ¹ King Mongkut's Institute of Technology Ladkrabang (KMITL), Thailand
	² Srinakharinwirot University, Thailand
F2-EMI-1-5	Prediction of the DM Conducted EMI in PWM Rectifier System
2:40pm	Lei Zhang, Weiming Ma and Jin Meng
	Naval University of Engineering, China
F2-EMI-1-6	Numerical Analysis of Electromagnetic Emission from Lightning Implement
3:00pm	Yoshihiko Namba ¹ , Tomohiko Morita ² and Katsuhiro Hirata ²
	¹ Matsushita Electric Works Analysis Center Co., Ltd.,
	² Osaka University, Japan

IF-1: EMC Industry Forum

Friday, 3 March 2006, 3:20pm-5:00pm

Chairs: Elya Joffe, Mark Montrose SUNTEC Room 208

F2-IF-1-1 3:20pm	Reverberation Chamber as a Radiation Source Patrik Svensén
	Saab bofors Dynamics Ab, Sweden
F2-IF-1-2	How to Generate Easily 3000V/m between 1 and 18 GHz
3:40pm	Jean-Francois Rosnarho, La Trinité sur Mer, SIEPEL, France
F2-IF-1-3	A Closer Look into Radiated Emissions Prescan Measurement Approach
4:00pm	Yong Chian Wong Hewlett Packard Singapore, Singapore
F2-IF-1-4	Managing Risks, Electrical and EMC on the High Speed Railway Project
4:20pm	Yin Kwong Leong ¹ , Chi Wong ² , Jonne TSE ³ and Femando Devis ⁴
	¹ QARS, Singapore
	² QARS, United Kingdom ³ QARS, Hong Kong, China
	⁴ Fedaring, Spain
F2-IF-1-5	Lightning Induced Surges on Coaxial Cables and its
	Protection Technique for Digital Transmission Interface (DTI)
4:40pm	A.Halim Samad and Mr Annuar Ramli Telekom R&D Sdn. Bhd., Malaysia

PCB-3: EMC at PCB Level-Modeling Issues Friday, 3 March 2006, 8:40am-10:20am

Chairs: Prof. Joungho Kim, Prof. Kye Yak See SUNTEC Room 209

Finite Difference Modeling of Multiple Planes in Packages
Arif Engin ¹ , Madhavan Swaminathan ¹ and Yoshitaka Toyota ²
¹ Georgia Institute of Technology, United States ² Okayama University, Japan
Impact of PCB Layout Design on Final Product's EMI Compliance
Kye Yak See ¹ , Manish Oswal ¹ , Werachet Khan- ngern ² , Flavio Canavero ³ , Christos Christopoulos ⁴ and Hartmut Grabinski ⁵ ¹ Nanyang Technological University, Singapore ² King Mongut's Institute of Technology Ladkrabang, Thailand ³ Politecnico di Torino, Italy ⁴ Nottingham University, United Kingdom ⁵ Hannover University, Germany
Teaching Near Field Coupling with PCB Layout Timothy Foo and Johnny Chee Ngee Ann Polytechnic, Singapore
Electromagnetic Compatibility of a Dual-Planar Electromagnetic Band-Gap Microstrip Filter Structure
Yee Hui Lee and Shao Ying Huang Nanyang Technological University, Singapore
Low Inductance Thin Film Capacitors for Decoupling Applications (Invited)
N. Kamehara ¹ , J.D. Baniecki ² , T. Shioga ² , K. Kurihara ² , M Mizukoshi ² ¹ Fujitsu Analysis Laboratory Ltd, Japan ² Fujitsu Laboratories Ltd. Japan

PCB-4: Circuit Simulation

Friday, 3 March 2006, 10:40am-12:20pm Chairs: Prof. Wenyan Yin, Dr. Toshio Sudo

SUNTEC Room 209

Behavior of Switching Noise and Electromagnetic Radiation in Relation to Package Properties and On-chip Capacitance (Invited)
Toshio Sudo Toshiba Corp., Corporate Manuf, Eng. Ctr., Japan
Toshibu Corp., Corporate Manar. Eng. Cu., japan
Radiated Emission Analysis from Printed Circuit Board Edges Using Multiple Stimulus Sources
Mark I. Montrose ¹ and En-Xiao Liu ²
¹ Montrose Compliance Services, Inc., United States
² Institute of High Performance Computing, Singapore
Electrical Analysis and Design of Differential Pairs Used in High-Speed Flip-Chip BGA Packages
Weiliang Yuan, Hsian Pang Kuah, Chuen Khiang Wang, Chong Yok Rue Desmond and Alfian Daengdora Muhamad
United Test and Assembly Center Ltd, Singapore
EMC Strategy in Wireless Sensor Packaging
Alessandro Gandelli, Francesco Grimaccia and R. E. Zich
Politecnico di Milano, Italy
Investigation of Interconnect Effects in a Transimpedance Amplifier
Xiaomeng Shi ^{1,2} , Zhenghao Lu ¹ , Jianguo Ma ¹ , Erping Li ² , Kiat Seng Yeo ¹ and Manh Anh Do ¹
¹ Nanyang Technological University, Singapore
² Institute of High Performance Computing, Singapore

ICEM-2: IC Packaging EM Modeling Friday, 3 March 2006, 1:20pm-3:00pm

Chairs: Prof. Jianguo Ma, Thomas Steinecke SUNTEC Room 209

F3-ICEM-2-1	Sensitivity of On-wafer Interconnects to CMOS Process Parameters at Radio Frequency
1:20pm	Xiaomeng Shi ^{1,2} , Erping Li ² , Jianguo Ma ¹ , Kiat Seng Yeo ¹ and Manh Anh Do ¹
	¹ Nanyang Technological University, Singapore ² Institute of High Performance Computing, Singapore
F3-ICEM-2-2 1:40pm	EMI Modeling and Simulation in the IC Design Process Thomas Steinecke ¹ , Dirk Hesidenz ¹ and Ekkehard Miersch ² ¹ Infineon Technologies AG, Germany ² EFM Consulting, Germany
F3-ICEM-2-3	Activity Based High Level Modeling of Dynamic Switching Currents in Digital IC Modules
2:00pm	Andreas Gstoettner ¹ , Thomas Steinecke ² and Mario Huemer ¹ ¹ University of Erlangen-Nuremberg, Germany
	21mmeon Technologies AG, Germany
F3-ICEM-2-4 2:20pm	EMC Analysis on Stacked Packages Ilkka Kelander, Matti Uusimäki and Ali Arslan Nokia Corporation, Finland
F3-ICEM-2-5 2:40pm	EMI Analysis of TFT-LCD Driver IC Sung Pil Choi ¹ , Jae Wook Kwon ¹ , Kye Eon Chang ¹ , Jin Tae Kim ¹ and Min Koo Han ² ¹ SAMSUNG ELECTRONICS CO.,LTD, South Korea ² Seoul National University, South Korea

MIL-1: EMC in Military

Friday, 3 March 2006, 3:20pm-5:40pm

Chairs: Dr. Wee-Jin Koh, Dr. Jean-Philippe Parmantier SUNTEC Room 209

F3-MIL-1-1 3:20pm	Analysis of E ³ on Naval Surface Combatants Avi Shechterl and Moshe Netzer ²	
5.20pm	¹ Alion-JIMA Martime Sector, United States	
	² EMC and Safety Engineering, Israel	
F3-MIL-1-2	On EMC of ISM COTS Devices used for Military Experimentation	
3:40pm	Kim-Seng Aw	
	DSO National Laboratories, Singapore	
F3-MIL-1-3	HPM: Effects on Systems and Protection	
4:00pm	Mats Backstrom	
	Swedish Defence Research Agency, FOI, Sweden	
F3-MIL-1-4	EMI Effects on a Generic Missile with IR Position Sensitive Detector	
4:20pm	Bruno Chevalier ¹ , Frank Sonnemann ² and Thomas Leibl ³	
	¹ Délégation générale pour l'armement, France	
	² Diehl BGT Detence, Germany ³ BWB Germany	
	bwb, cernary	
F3-MIL-1-5	Consideration of the Packaging of HPM Sources on EMC Effects	
4:40pm	Edl Schamiloglu	
	University of New Maxico, United States	
F3-MIL-1-6	Investigation on the Connection of a Type A Lightning Strike to a Vertical Cable Conduit Installed Inside a	
	Warship Integral Mast Structure	
5:00pm	Yannick Le-Golvan ¹ , G. Pensec ¹ , D. Quiltu ¹ , J-P.Parmantier ² ,	
	X. Ferrieres ² , E Bachelier ² and S. Bertuol ²	
	¹ DCN, France	
	² ONERA, France	
F3-MIL-1-7	Military System EMC Engineering in Singapore	
5:20pm	Chow Wee Sing, Simon Yip, Foo Say Ping and Foo Sek Joon	
	ST Electronics (Info-Comm Systems) Pte Ltd, Singapore	

PROT-1: EMC Protection

Friday, 3 March 2006, 8:40am-10:20am

Chair: Dr. William Radasky SUNTEC Room 207

Electrical Strength of Distribution Insulators under Steep Front, Short Duration Pulse
Stanislaw Grzybowski ¹ , John Kappenman ² and William Radasky ²
¹ Mississippi State University, United States
² Metatech Corporation, United States
Experimental Investigation of Shielding Effects due to the Presence of Nearby Parallel Conductors
Yan-zhao Xie ^{1,2} , Zan-ji Wang ¹ , Qun-shu Wang ² , Hui
Xiang ² and Xin Nie ²
¹ Tsinghua University, China
² Northwest Institute of Nuclear Technology, China
Analytical and Experimental Study of the Shielding
Effectiveness of a Metallic Enclosure with Off-Centered Apertures
Farhana Ahmad Po'ad ¹ , Mohd. Zarar Mohd. Jenu ¹ , C.
Christopoulos ² and D. Thomas ²
² University of Nottingham, United Kingdom
A Study of EMI Suppression Characteristics of Ferrite
Junichiro Urabe, Katsumi Fujii, Armad Mukifza, Yasushi Matsumoto and Akira Sugiura
Tohoku University, Japan

PROT-2: Shielding EMC

Friday, 3 March 2006, 10:40am-12:20pm

Chairs: Prof. Jinliang He, Dr. Toshihide Tosaka SUNTEC Room 207

F4-PROT-2-1	Shielding Performance of a Metallic Rack used for Telecommunication Equipment: FIT Modeling and Measurements
10:40am	Antonio Ciccomancini Scogna CST of America Inc., United States
F4-PROT-2-2	Feasibility Study for Reconstruction of Information from Near Field Observations of the Magnetic Field of a Laser Printer
11:00am	Toshihide Tosaka ¹ , Kazumasa Taira ² , Yukio Yamanaka ¹ , Atsuhiro Nishikata ^{1,3} and Mitsuo Hattori ⁴ ¹ National Institute of Information and Communications Technology, Japan ² Ministry of Internal Affairs and Communications, Japan ³ Tokyo Institute of Technology, Japan ⁴ NTT Advanced Technology Corporation, Japan
F4-PROT-2-3	Simulation and Measurement of the Transient Field of Indirect Electrostatic Discharge
11:20am	Zhiyong Yuan, Tun Li, Jinliang He, Shuiming Chen, Weiyuan Chen, Rong Zeng Tsinghua University, China
F4-PROT-2-4 11:40am	High Frequency (HF) Suppression with a Shielded Fence Wee Jin Koh, Joo Huat Tan and Chew Hock Kek DSO National Laboratories, Singapore
F4-PROT-2-5	Time-Domain Measurements of Transient Field Coupling Through Slots
12:00pm	Wee Jin Koh, Joo Huat Tan, Yeow Kwang Tai and Chew Hock Kek DSO National Laboratories, Singapore

POW-2: Power System EMC

Friday, 3 March 2006 1:20pm-3:00pm Chairs: Prof. Michel Ianoz, Prof. Cui Xiang

SUNTEC Room 207

F4-POW-2-1	Full Harmonic Load Flow Calculation in Power Systems for Sensitivity Investigation		
1:20pm	Cezary Dzienis ¹ , Andrzej Bachry ² and Zbigniew Styczynski ¹ ¹ Otto-von-Guericke-University of Magdeburg, Germany ² Siemens AG, Germany		
F4-POW-2-2	A Simple Method for Measuring Complex Transfer Impedance and Admittance of Shielded Cable in Substations		
1:40pm	Lei Qi, Xiang Cui, Xuesong Gu North China Electric Power University, China		
F4-POW-2-3	The Conducted Electromagnetic Interference of Small Grid Connected Inverter to Power System		
2:00pm	P. Khamphakdi ¹ , V. Tarateeraseth ² , K. Karanun ³ and W. Khan- ngern ¹ ¹ King Mongkut's Institute of Technology Ladkrabang (KMITL), Thailand ² Srinakharinwirot University, Thailand ³ Electrical and Electronics Institute (EEI), Thailand		
F4-POW-2-4	On the Mechanisms of Differential-Mode to Common-Mode Conversion in the Broadband over Power Line (BPL) Frequency Band		
2:20pm	Ana Vukicevic ¹ , Marcos Rubinstein ² , Farhad Rachidi ¹ , Jose-Luis Bermudez ³ ¹ Swiss Federal Institute of Technology, Switzerland ² University of Applied Science of Western Switzerland, Switzerland ³ ABB Secheron, Switzerland		
F4-POW-2-5 2:40pm	High-frequency EMTP Model of Transformer Windings Guishu Liang ¹ , Huaying Dong ¹ , Xiaohui Wang ² , Xile Zhang ^{1,3} , Haifeng Sun ¹ and Xiang Cui ¹ ¹ North China Electric Power University, China ² Hebei Electric Power Research Institute, China ³ Baoding Tianwei Baobian Electric Co., Ltd, China		

Exhibition

Exhibition Hours 1 March-Wednesday, 08:30am – 6:00pm Singapore Suntec Level 3 Concourse

2 March – Thursday, 08:30am – 6:00pm Singapore Suntec Level 3 Concourse

3 March – Friday, Closes 5:00pm Singapore Suntec Level 3 Concourse

Program

Exhibition Booth Set-up by Exhibition Services Provider 28 February - Tuesday, 9:00am – 2:00pm Singapore Suntec Level 3 Concourse

Exhibition Booth Dressing by Exhibitors

28 February - Tuesday, 3:00pm – 8:00pm Singapore Suntec Level 3 Concourse

Exhibition Booth Tear Down

3 March – Friday, 5:00pm – 6:00pm Singapore Suntec Level 3 Concourse

Exhibitors

List of Exhibitors

S/N	Organization Name	Booth No.
1	Albatross Projects Gmbh	C6
2	Advanced Materials & Integration Co.Ltd	C3, C4, C5
3	AR Worldwide	C2
4	Chang Sung Corporation	C3, C4, C5
5	Cosmotec Enterprises Pte Ltd	A2
6	CST Computer Simulation Tech	A13
7	Dong-II Technology Ltd	C3, C4, C5
8	EMCIS	C3, C4, C5
9	EM Software & Systems	A1
10	EM Test GmbH	E1
11	Epsilon Corporation	C3, C4, C5
12	ETS-Lindgren	D1, D2
13	Fair-Rite Asia Pte Ltd	A12
14	Fastus Scientific Corporation	A7
15	Flomerics SE Asia Pte Ltd	A10
16	Frankonia GmbH	A8
17	Glocom Marketing Pte Ltd	C8
18	IEEE/ EMC	D9
19	Journal Safety & EMC China	D8
20	JS Denki	C9, C10
21	LabOne Singapore Pte Ltd	C7
22	NARTE	A11
23	PRÂNA	D10
24	PSB Corporation	C1
25	Quantel Pte Ltd	A14
26	Rohde & Schwarz Systems	B2
27	Schaffner EMC Pte Ltd	B3
28	SIEMIC Laboratories	D11
29	Speedy Tech	A4
30	ST Electronics (Info-Comm Systems)	B1
31	Sunkyoung Silicone Tech Co.Ltd	C3, C4, C5
32	TME Systems Pte Ltd	A5, A6
33	TNC Co.Ltd	C3, C4, C5
34	World Scientific Publishing	A9

ALBATROSS C~ PROJECTS

Albatross Projects GmbH (Booth No: C6)

Albatross Projects GmbH is an international positioned enterprise for the implementation of EMC Test Systems. We offer customised solutions and advanced technology in these fields:

- Anechoic Chambers
- Antenna Chambers
- Shielded Enclosures
- Tempest Facilities

We are focusing on superior quality for turnkey solutions to provide our customers with valuable equipment. Rely on our commitment to excellent service.



Advanced Materials & Integration Co.Ltd (Booth No: C3, C4, C5)

With our trademark "Expan" AMIC is providing total solution for the EMI/ESD/SAR/RFI by own EMC products manufactured in Korea. Our product ranges are Shielding, Absorbing, Thermal including Form in Gasket, EMI Paint, Conductive Silicone is a new Absorber for RF-ID tag applicable. Especially, our new item RF-Tape is dual performance is shielding/absorbing.



AR Worldwide (Booth No: C2)

AR Worldwide RF/Microwave Instrumentation is a world class manufacturer of broadband high-power amplifiers from dc to 40 GHz, from 1 – 50,000 watts. These amplifiers are primarily used for radiated and conducted susceptibility testing, but are equally suitable for general laboratory use. Available test accessories include antennas, directional couplers, field monitoring equipment, power meters and precompliance EMC test systems.



Chang Sung Corporation (Booth No: C3, C4, C5)

Chang Sung Corporation is one of the world's leading manufacturer of EMC products based on High Quality, Advance Technologies, and Qualified Staff & Equipment. It's production range is EMI Paste, Absorber Sheet, RF-ID Inductor Sheet, Magnetic Powder core, Magnetic Filler, Conductive Filler with wide range of standard specification and customized design. <u>www.changsung.com</u>



Cosmotec Enterprises Pte Ltd (Booth No: A2)

Founded in 1983, Cosmotec Enterprises is an established company in the test and measurement instrumentation business. With EMC business being one of our key focus technologies market, Cosmotec is committed to complete customer satisfaction by providing solutions founded on excellent engineering support and services, integrated solutions, and valued added services.



CST Computer Simulation Tech (Booth No: A13)

CST is one of the two largest suppliers of electromagnetic simulation software and has continuously enhanced its position as market and technology leader in 3D Time Domain simulation. With over 80 employees worldwide and a network of qualified distributors, 120 people are dedicated to the development and support of its EM products in more than 30 countries. Information about CST is available on the web at <u>www.cst.com</u>



Dong- ll Technology Ltd (Booth No: C3, C4, C5)

Dong-ll Technology is a total EMC solution provider since 1986, offering hundreds kinds of products as measures for conducted and radiated emission. Our major product lines are IEC Inlet Filter, Common mode and harmonics choke, Sockets, Fabric gaskets and customer specific products, and so on.



EMCIS (Booth No: C3, C4, C5)

EMCIS is one of creative solution provider in electromagnetic compatibility (EMC) analysis instruments and its related equipments/accessories. Approaching into new concept of noise separation in Conducted Emission Noise(EMI) as Common-Mode and Differential-Mode noise, provides faster, accurate, and perfect EMI solution including just-on size filter design.



EM Software & Systems (*Booth No: A1*)

FEKO <u>www.feko.info</u> is a comprehensive computational electromagnetics (CEM) code based on the accurate "full wave" Method of Moments. The leading MLFMM and the MoM hybrid with asymptotic high frequency techniques (PO and UTD) allows simulation of electrically large problems, e.g. antenna placement. Several techniques including Finite Element Method (FEM) available for dielectric regions.



EM TEST GmbH (Booth No: E1)

EM TEST is worldwide the leading supplier of EMC generators for the automotive industry and among the leaders for IEC, telecom, medical and component testing. Our transient generators match test routines exactly to specifications. Our senior engineers are active members in national and international standards committees. <u>www.emtest.com</u>



Epsilon Corporation (Booth No: C3, C4, C5)

Epsilon Silver Coated Copper powders are designed to provide the best EMI solution for modern electro-communication equipment. Silver offers the best electrical conductivity, thus is used as the coating. Epsilon's products are Silver Coated Glass powder, Silver Coated Hollow Glass Powder, Silver Coated Aluminum powder, Ag Core Pd Shell powder, Ag Flake powder.



ETS-Lindgren (Booth No: D1, D2)

ETS-Lindgren is the proven world leader for EMC, wireless and microwave test systems and components. Our product line includes antennas, anechoic, reverb and acoustic chambers, positioners, test cells, antenna pattern measurement software and systems, shielding, GTEM /TEM Cells, probes and more. Click at <u>www.ets-lindgren.com</u> for more information.



Fair-Rite Asia Pte Ltd (Booth No:A12)

LISTING OF PRODUCTS TO BE EXHIBITED Ferrite Products for the Electronic Industry:

Board Components	Shield Beads, Beads on Lead, Surface Mount Beads, Chip Beads, Wound Beads, Multi-Aperture Cores
Cable Components	Round Camble EmI Suppression Cores, Split Round Cable EMI Suppression Cores, Round Cable Snap-its, Flat Cable EMI Suppression Cores, Flat Cable Snap-its
Inductive Components	Rods, Toroids, E & I Cores, U Cores



Faustus Scientific Corporation (Booth No: A7)

Faustus Scientific Corporation translates cutting-edge research expertise into "Multi-Purpose Electromagnetic Field Simulation Tools": MEFiSTo[™]. These fast, accurate, and user-friendly 3D Time Domain CAD tools offer outstanding versatility and value. They empower design engineers, researchers and educators to solve challenging electromagnetic field problems. Ask for a free trial version and visit our website at <u>http://www.faustcorp.com/</u>

FLOMERICS

Flomerics SE Asia Pte Ltd (Booth No: A10)

Flomerics provides simulation software tools and services - primarily to the electronics industry - to improve and accelerate the physical design process. There are (FLOTHERM, FLO/EMC, FLO/PCB, FLOPACK, FLO/MCAD, SmartParts3D, Micro-Stripes). Our software enables engineers to predict the behavior of a proposed design prior to the build and test phase - this is often called "virtual-prototyping".



Frankonia GmbH (Booth No: A8)

FRANKONIA GmbH, a leading worldwide company specialized in RF shielded rooms, anechoic chambers, microwave absorbers and chambers accessories, like: turntables, antenna mast, controllers cctv and audio systems. Well known for its quality and its non combustible absorbers, Frankonia is certified ISO 9001 for research, development, manufacturing, installation and chambers tests.

GLOCOM MARKETING PTE LTD Your source for EMC products

Glocom Marketing Pte Ltd (Booth No: C8)

Glocom Marketing Pte Ltd was incorporated in year 1983. We are a leading provider of innovative Electromagnetic Interference (EMI) shielding products and solutions for the Electronic Manufacturing Industry. We positioned ourselves as an integrated One-stop EMI Solutions provider with our wide range of EMI products for the flexibility of Design applications to your entire possible EMI problem.



IEEE / EMC (Booth No: D9)

IEEE (Eye-triple-E) EMC Society (<u>http://www.emcs.org</u>) is one of the 39 societies under IEEE. It is a non-profit, technical professional association providing services in the areas of electromagnetic.

安全与电磁兼容

Journal Safety & EMC China (Booth No: D8)

SAFETY & EMC is a science and technology periodical issued by the Chinese Electronic Standardization Institute. It has been established for over sixteen years and publishes 6 issues annually. This periodical covers the standards, testing, certification, design and many other aspects of EMC. In China, more than 100,000 engineers are our faithful readers.



JS Denki Pte Ltd (Booth No: C9, C10)

JS Denki is a 100% EMC Test & Measurement Solution Company with an experienced and technically competent group who are fully committed in the EMC field. As a customer oriented company, we provide customize EMC solution and high quality after sales support to our value customers because customer satisfaction is our main objective.



LabOne Singapore Pte Ltd (Booth No: C7)

LabOne's mission: To provide one-stop testing and certification services for ISM, ITE and AV products. LabOne has aggressively expanded its state-of-art facilities with a recent investment of S\$40million in Asia Pacific. LabOne is geared towards bolstering its position to support high-end product manufacturing and R&D activities and in being the biggest independent test centre for electronics and consumer products in Asia Pacific.



NARTE (Booth No: A11)

NARTE, a non-profit organization, certifies qualified practitioners of EMC/EMI control. The purpose of NARTE EMC Certification is to foster technical excellence in EMC engineering. This approach establishes competency criteria for EMC/EMI work certification benefits the individual engineer or technician and the EMC community by establishing a standard of excellence in EMC.



PRANA (Booth No: D10)

PRÂNA is the European leading manufacturer of broadband RF pulsed or CW amplifiers. PRÂNA range of amplifiers covers a bandwidth from DC to 4,2 GHz with power levels up to 20 KW according to the applications. Reliable and robust, PRÂNA amplifiers are guaranteed to provide a defined stable power whatever the load mismatch is.



PSB Corporation (Booth No: C1)

PSB Corporation is an authorised test house of the Infocomm Development Authority of Singapore (IDA), and recognised by the Federal Communications Commission (FCC) in the US. Our test reports are accepted by many authorities, including countries under the Asia Pacific Economic Cooperation (APEC) MRA.



Quantel Pte Ltd (Booth No: A14)

Set up in 1989, Quantel has earned its reputation as a supplier of high quality, customer-oriented products in the field of power electronics, safety and EMC compliance testing in the SE Asia region. Quantel will showcase the latest EMC related test equipment in EMC-Zurich 2006 Exhibition.



Rohde & Schwarz Systems (Booth No: B2)

Rohde & Schwarz is one of the world's leading manufacturers of EMI, communication, signal analysis and signal generation equipment. We are leaders in turnkey EMI and EMS test systems. With 6000+ employees worldwide, subsidiaries and representatives in over 70 countries, you are assured of responsive support for all your EMC applications. For expert support committed to EMC, call us at 65-68463710 or www.rohde-schwarz.com.sg

IIISCHaffner

Schaffner EMC Pte Ltd (*Booth No: B3*) **Schaffner - safety for electronic systems**

Schaffner is the international leader in electromagnetic compatibility (EMC), focusing on high-growth sectors such as automotive, building automation, industrial and consumer electronics, aerospace, medical technology, power supplies, telecommunications, transportation, and the public sector. The Schaffner Group develops, produces and markets standard and customer-specific components, modules, test systems and test facilities.



SIEMIC Laboratories (Booth No: D11)

Headquartered in the heart of Silicon Valley with facilities and offices around the world, SIEMIC provides one-stop shop compliance testing and global certification services. With distinguished accreditation, SIEMIC Test Report is acceptable worldwide. SIEMIC Certification service covers over 220 countries that assist our clients access to the global markets. <u>www.siemic.com</u>



Speedy-Tech Electronics Ltd (Booth No: A4)

Founded in year 1985, Speedy-Tech is an Electronic Manufacturing Service (EMS) provider and specializes in design and manufacturing of power converters. In year 2004, a world class EMC 10m testing chamber was setup, combining with other EMC testing facilities for provision of Power Electronics solutions and EMC test services to the MNC customers based in Singapore and Asia.

Singapore Technologies Electronics

Singapore Technologies Electronics (*Booth No: B1*)

ST Electronics, the electronics arm of ST Engineering, delivers innovative system solutions to defence, homeland security, commercial and industrial customers worldwide. A leader in Asia Pacific for EMC, RF/Microwave engineering and wireless communications, ST Electronics offers a range of solutions and services:

- Architectural Shielding Systems & Solutions
- EMI/EMC Consultancy, Test & Measurement Services
- One-stop Instrument Calibration Centre for Calibration & Repair of Test, Measuring & Diagnostic Equipment



Sunkyoung Silicone Tech Co.Ltd (Booth No: C3, C4, C5)

SunKyoung Silicone Tech Co.Ltd produces a special Product of general silicone rubber, sponge silicone rubber, EMI Conductive silicone elustomer, etc.



TME Systems (Booth No: A5, A6)

Established in 1986, TME Systems, its regional offices and affiliates have been providing customers with an international range of reputable products that come with strong research and development emphasis as well as high manufacturing standards.

Our products enable users to achieve higher productivity and efficiency whether in the office, the manufacturing plant, the laboratory, or the worksite.



TNC Co. Ltd (Booth No: C3, C4, C5)

TNC Co.Ltd specialized manufacturer of the Line Filter for EMI (CE) counterplan have saveral type of standard products. The fine quality has been making us enjoying a good reputation by our customers as our products are superior to those that are distributing now in our market. We hope to best helper concerning EMI(CE) counterplan for you.



World Scientific Publishing (Booth No: A9)

Established in 1981, World Scientific publishes more than 400 books and 100 journals annually in Science, Technology and Medicine. The company also holds exclusive rights to publish the complete series of Nobel lectures from 1901 onwards. In 1995, World Scientific co-founded the Imperial College Press with London University's Imperial College.



Meeting Matters International

Meet Matt, with its extensive network in the Asia Pacific, provides planning and operational support an organisation needs for its meetings and events. From the initial planning stage to the conclusion of the event, Meet Matt assists in managing a myriad of activities that contribute to a successful meeting or event. Meet Matt is a World Scientific subsidiary.



ST Electronics - Your Partner in EMC, RF/Microwave Engineering & Wireless Communications

At ST Electronics, we deliver innovative system solutions to government, defence, homeland security, commercial and industrial customers worldwide. A leader in Asia Pacific for EMC, RF/microwave engineering and wireless communications, we have more than two decades of experience and track records which consistently meet the stringent demands of our customers. We are committed to offer quality services to all our customers, so you can rely on our wide range of turnkey solutions and services to suit each of your business needs.

EMC Services & Consultancy

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- EMC Consultancy & Control Management Services
- Military & Commercial EMC Test & Measurement Services

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Singapore Technologies Electronics ۲

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Composite

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